

ACCURACY ANALYSIS FOR
A LOWER CONFIDENCE LIMIT PROCEDURE
FOR SYSTEM RELIABILITY

Thomas Robert Gatliffe

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THESIS

ACCURACY ANALYSIS FOR
A LOWER CONFIDENCE LIMIT PROCEDURE
FOR SYSTEM RELIABILITY

by

Thomas Robert Gatliffe

September 1976

Thesis Advisor:

W. M. Woods

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FOR SYSTEM RELIABILITY

by

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Lieutenant-Commander, United States Navy
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ABSTRACT

This thesis examines a proposed empirical method for determining the the $100(1-\alpha)\%$ lower confidence limit for the reliability of a system composed of a mixture of series and parallel connected components for which only component level test data is available. The method is an extension of the Log-gamma procedure originally proposed for series connected systems only. The accuracy of the method is assessed for some representative system reliability constructs using a computer simulation procedure. The simulation results are examined with a view toward identification of accuracy indication parameters which may be estimated prior to the component tests.

TABLE OF CONTENTS

I.	INTRODUCTION.....	7
II.	THE PROCEDURAL MODEL.....	9
	A. DEVELOPMENT FOR SERIES SYSTEMS.....	9
	B. REVISION FOR SERIES-PARALLEL SYSTEM.....	14
	C. SPECIAL CIRCUMSTANCES.....	15
III.	THE SIMULATION.....	17
	A. PROCEDURE.....	17
	B. DESCRIPTION OF THE CASES.....	19
	1. General.....	19
	2. Cases One Through Twelve.....	20
	a. Reliability Block Diagram.....	20
	b. Test Parameters.....	20
	(1) Number of Tests.....	20
	(2) True Reliabilities.....	21
	3. Case Thirteen.....	21
	a. Reliability Block Diagram.....	21
	b. Test Parameters.....	21
	c. Discussion.....	22
	4. Cases Fourteen Through Twenty-one and Thirty Through Thirty-three.....	22
	a. Reliability Block Diagram.....	22
	b. Test Parameters.....	22
	(1) Number of Tests.....	22
	(2) True Reliabilities.....	23
	c. Discussion.....	23
	5. Cases Twenty-two Through Twenty-nine.....	24
	a. Reliability Block Diagram.....	24
	b. Test Parameters.....	24
	(1) Number of Tests.....	24
	(2) True Reliabilities.....	25

C. Discussion.....	25
IV. RESULTS AND CONCLUSIONS.....	27
A. SIMULATION RESULTS.....	27
B. ANALYSIS OF RESULTS.....	28
1. General Characteristics.....	28
2. Derivation and Discussion of TT.....	30
3. Accuracy Prediction.....	33
4. Comparison with Earlier Results.....	33
C. CONCLUSIONS.....	35
Appendix A: DERIVATION OF UNBIASED ESTIMATE FOR \hat{T}_i	38
Appendix B: APPROXIMATION OF $\text{VAR}[\hat{T}_i]$ BY T_i/N_i	40
Appendix C: SPECIAL CONSIDERATIONS WHEN \hat{S} EQUALS ZERO..	44
Appendix D: TABULATED SIMULATION RESULTS.....	48
Appendix E: REGRESSION OF OBSERVED ACCURACY.....	83
Appendix F: COMPUTER PROGRAM.....	89
LIST OF REFERENCES.....	90
INITIAL DISTRIBUTION LIST.....	98

I. INTRODUCTION

Often, in the design and production of complex systems, an important question to be answered early in the process concerns the demonstrable system reliability based upon observed mission test results. Usually only components and minor subassemblies can be tested in any but the very latest stages of production. For reasons of prototype cost, the lack of complete systems for early tests, the expense involved in total system operational tests, and the need to make production decisions as early as feasible, reliance must be shifted to the component test results to provide at least an approximate answer to this question. Component data must be used in spite of the moderately strong assumptions needed to transform such test results into an estimate of overall system reliability.

Since estimates are, by their nature, inexact, it would be reasonable to expect that the most credible estimate would be one which was both conservative and carried with it an indicator of the degree of conservatism associated with its computation. This, of course, is a description fitting a lower confidence limit when referring to estimates of system reliability. Thus, when one speaks of a "100(1- α)% lower confidence limit" and obtains a value for it, the assertion is that the obtained lower confidence limit value is less than the actual system reliability with probability $1-\alpha$.

In 1968, J. R. Borsting and W. M. Woods developed what is known as the Log-Gamma method for computing lower confidence limits for system reliability based upon

component mission test results only [Ref. 1]. As originally developed, the Log-Gamma method was restricted to systems composed of all series connected components. It did, however, offer the advantage of allowing for unequal sample sizes, so the number of component tests could vary arbitrarily from component to component without degrading the procedure accuracy. In addition, no assumption is needed concerning the failure distribution of any component.

Woods has recently proposed a modification to the procedure which, it was hoped, would extend its application to a mixed system of series and parallel connected components. The purpose of this study is to assess the accuracy of the revised procedure when applied to some typical component failure data from several representative series and series-parallel systems. An attempt is also made to discern parameters (constructed from or inherent to the sample data, component reliability goals, testing plan, and system design) which could provide useful indicators of the expected accuracy of the procedure.

II. THE PROCEDURAL MODEL

It should be noted that two rather strong assumptions need to be made with respect to system and component reliabilities. First, it must be assumed that component tests were conducted in a test environment not unlike that encountered in the system operational mission environment profile. Second, no component reliability degradation will result from interactions with other components when assembled into the system. The degree to which these two assumptions are met will have an unknown but potentially great effect upon the validity of the model and indeed upon the whole concept of system reliability prediction from component attributes data.

A. DEVELOPMENT FOR SERIES SYSTEMS

This section gives a modified and elaborated development of the basic reliability model and estimation procedure based upon that presented by Woods and Borsting [Ref. 1].

For a system of k components in logical series, the system reliability, R_s , can be expressed in terms of the individual component reliabilities as the product

$$R_s = \prod_{i=1}^k P_i \quad (2.1)$$

where P_i is the true reliability of the i -th component. From P_i the component unreliability, Q_i , is defined as

$$Q_i = 1 - P_i.$$

Taking the natural logarithm in equation (2.1) and defining the new variable, S:

$$S = -\ln R_S = -\sum_{i=1}^k \ln(1-Q_i) \quad (2.2)$$

The natural logarithm can be expanded by the infinite series

$$\ln(1-x) = -\sum_{j=1}^{\infty} \frac{x^j}{j} \quad \text{for } 0 \leq x \leq 1$$

$$S = \sum_{i=1}^k \sum_{j=1}^{\infty} \frac{(Q_i)^j}{j} \quad (2.3)$$

$$S = \sum_{i=1}^k [Q_i + Q_i^2/2 + Q_i^3/3 + \dots]$$

For Q_i small, say 0.1 or less, the above series may be approximated by the first two terms with a maximum error of 0.34% of the true value. Thus,

$$S \approx \sum_{i=1}^k [Q_i + Q_i^2/2] = \sum_{i=1}^k T_i \quad (2.4)$$

where $T_i = Q_i + Q_i^2/2$. For the remainder of the derivation this approximation is treated as an equality.

Appendix A derives an unbiased estimator, \hat{T}_i , for T_i :

$$\hat{T}_i = A_i \hat{Q}_i + B_i [\hat{Q}_i^2]/2 \quad (2.5)$$

where $A_i = [2N_i - 3]/[2N_i - 2]$

$$B_i = N_i/[N_i - 1]$$

$$\hat{Q}_i = F_i/N_i$$

and, / F_i is the number of failures resulting from N_i mission tests conducted on the i -th component.

An unbiased estimator of S will be obtained from

$$\hat{S} = \sum_{i=1}^k \hat{T}_i \quad (2.6)$$

\hat{S} will be an unbiased estimator of S , since it is the sum of the unbiased estimators, \hat{T}_i , of T_i .

Appendix B shows that, for the reasonably expected range of values for Q_i and N_i , the variance of \hat{S} may be approximated

$$\text{Var}[\hat{S}] = \sum_{i=1}^k \text{Var}[\hat{T}_i] \approx \sum_{i=1}^k [T_i/N_i] \quad (2.7)$$

By intuitively assuming the probability distribution of \hat{S} is of the gamma type with parameters r and θ , an expression can be derived for a confidence interval for R_s .

The gamma probability density may be written as

$$f_{\hat{S}}(x, r, \theta) = \begin{cases} \frac{1}{\Gamma(r)} x^{r-1} e^{-x/\theta} & x \geq 0 \\ 0 & x < 0 \end{cases} \quad (2.8)$$

with mean = $r\theta$ and variance = $r\theta^2$.

To determine the values of r and θ , the following relationships are established:

$$E[\hat{S}] = r\theta \quad \text{from Eq. (2.8)}$$

$$E[\hat{S}] = \sum_{i=1}^k T_i \quad \text{from Eq. (2.4)}$$

$$\text{Var}[\hat{S}] = r\theta^2 \quad \text{from Eq. (2.8)}$$

$$\text{Var}[\hat{S}] = \sum_{i=1}^k \frac{T_i}{N_i}$$

These equations may be solved simultaneously to yield the

following expressions for r and θ :

$$r = \frac{\left[\sum_{i=1}^k T_i \right]^2}{\sum_{i=1}^k \frac{T_i}{N_i}} \quad \text{and} \quad \theta = \frac{\sum_{i=1}^k \frac{T_i}{N_i}}{\sum_{i=1}^k \frac{T_i^2}{N_i}}$$

and an estimator, \hat{r} , for r would be

$$\hat{r} = \frac{\left[\sum_{i=1}^k \hat{T}_i \right]^2}{\sum_{i=1}^k \frac{\hat{T}_i}{N_i}} \quad (2.9)$$

Note that for \hat{S} distributed as gamma(r, θ), $2\hat{S}/\theta$ will be distributed as chi-square with $2r$ degrees of freedom [Ref. 2, p. 181]. The following probability statements can then be made:

$$1-\alpha = P\left[\frac{2\hat{S}}{\theta} \geq \chi^2_{2r, 1-\alpha}\right] \quad (2.10)$$

$$1-\alpha = P\left[\theta \leq \frac{2\hat{S}}{\chi^2_{2r, 1-\alpha}}\right]$$

Since $\theta = E[\hat{S}]/r$ from Eq. (2.8) and $E[\hat{S}] = -\ln R_S$ from Eq. (2.2),

$$1-\alpha = P\left[\frac{-\ln R_S}{r} \leq \frac{2\hat{S}}{\chi^2_{2r, 1-\alpha}}\right]$$

$$1-\alpha = P\left[\ln R_S \leq \frac{-2r\hat{S}}{\chi^2_{2r, 1-\alpha}}\right]$$

Thus the $100(1-\alpha)\%$ lower confidence limit, $R_S^{*(\alpha)}$, for R_S is

$$R_S^{*(\alpha)} = \exp\left[\frac{-2r\hat{S}}{\chi^2_{2r, 1-\alpha}}\right] \quad (2.11)$$

A $100(1-\alpha)\%$ lower confidence limit estimate, $\hat{R}_S^{*(\alpha)}$, for R_S would be

$$\hat{R}_S^{*(\alpha)} = \exp\left[\frac{-2\hat{r}\hat{s}}{\chi^2_{[2\hat{r}], 1-\alpha}}\right] \quad (2.12)$$

The primary difficulty this formulation presents lies in the non-integer nature of values for $2\hat{r}$ as defined. Although some computer routines are available to approximate chi-square values with non-integer degrees of freedom, most users would find such a requirement difficult to fulfill at least. Therefore $2\hat{r}$ is replaced with the expression

$$[2\hat{r}] = \text{smallest integer } \geq 2\hat{r}$$

This is justified by noting that the ratio of the chi-square value divided by its number of degrees of freedom varies slowly with changes in the degrees of freedom for values of degrees of freedom greater than about five. Further, since $2\hat{r}$ may be changed moderately, by up to 1.0, without great change in the ratio value, it is reasonable to expect that

the probability distribution of $\chi^2_{[2\hat{r}], 1-\alpha}$ has small

variance. This expression can be substituted into equation (2.12) to yield

$$R_S^{*(\alpha)} = \exp\left[\frac{-[2\hat{r}]\hat{s}}{\chi^2_{[2\hat{r}], 1-\alpha}}\right] \quad (2.13)$$

Since the computer routines available for this research included the capability of computation of chi-square values with non-integer degrees of freedom, some simulation runs were performed using both equations (2.12) and (2.13) for comparison. The results indicated that the effects were limited to the third decimal place at worst and thus had little significance with respect to the procedural accuracy.

B. REVISION FOR SERIES-PARALLEL SYSTEM

Proceding from the strictly series system procedure developed above, the principal revision for the mixed series-parallel system procedure was to redefine \hat{f}_i and \hat{r} as follows:

$$\hat{t}_i = \begin{cases} A_i \frac{F_i}{N_i} + B_i \frac{F_i^2}{2N_i^2} & i=1, 2, \dots, K_1 \\ (1-\hat{R}_i) + (1-\hat{R}_i)^2/2 & i=K_1+1, \dots, K_2 \end{cases} \quad (2.14)$$

$$\hat{r} = \max \left[1.0, \frac{\left[\sum_{i=1}^{K_1+K_2} \hat{t}_i \right]^2}{\sum_{i=1}^{K_1+K_2} \frac{\hat{t}_i}{N_i}} \right] \quad (2.15)$$

$$\hat{S} = \sum_{i=1}^{K_1+K_2} \hat{t}_i \quad (2.16)$$

where A_i , B_i , F_i , and N_i are defined as before
 K_1 is the number of series components
 K_2 is the number of series-parallel subassemblies interconnected in series

\hat{R}_i is the reliability point estimate for the i -th subassembly determined in the usual manner from the individual point estimates for the subassembly components as derived from the raw failure data.

Although some comparison runs were made using A_i and B_i coefficients for the subassembly contribution to \hat{S} , no significant improvement in accuracy was noted and the use of these coefficients in this manner was abandoned due to the difficulty of computation with varying sample sizes within a subassembly.

C. SPECIAL CIRCUMSTANCES

In the event of no failures in any components or a lack of sufficient failures in subassembly components such that the basic procedure yields an \hat{S} value of zero and, thus, a system reliability lower confidence limit estimate of one, an alternate approach must be employed.

Statistically, the optimum solution might be to continue testing until sufficient component failures have been observed such that the above conditions no longer exist. However, such a solution might also not be economically feasible. Therefore, the simulation included provision for an alternate procedure when \hat{S} equals zero at the end of the programmed number of tests on all components. In addition, several cases were included where such conditions would be expected to exist in a significant number of the simulation runs, in order to observe the efficacy of the alternate procedure.

The derivation of this alternate procedure is given in Appendix C. The procedure may be summarized as follows:

(i) Find the series component or subassembly with the smallest actual or equivalent number of trials, N or N' , respectively. (See section IV.B.1)

(ii) Change the number of component or subassembly failures to F' by the following scheme:

α	F'	
0.2	0.37	NOTE: For best results, N or
0.1	0.25	N' should be at least 10.
0.05	0.16	

If a subassembly was selected, treat the subassembly as a component with F' failures out of N' mission trials for the remainder of this procedure.

(iii) Recompute the lower confidence limit estimate using the basic log-gamma procedure with the revised failure data. This estimate is approximately equivalent to α raised to the $1/N$ power as explained in Appendix C.

III. THE SIMULATION

A. PROCEDURE

The computer simulation program is listed in Appendix F. The following procedure was incorporated into the program:

Step One: Initialize and read in values for the total number of components in series, K_1 , the number of subassemblies in series, K_2 , the number of components within each subassembly, the number of tests performed upon each component, N_i , the true reliability of each component, R_i , and the seed value for the random number generator.

Step Two: For each component in turn, generate the observed number of failures as a binomially distributed random variable, F_i , with parameters N_i and $(1-R_i)$.

Step Three: Compute \hat{T}_i for each series component and subassembly, \hat{S} from the sum of the \hat{T}_i , and \hat{r} according to equations (2.14), (2.15), and (2.16) respectively.

Step four: Compute the resulting estimate of the $100(1-\alpha)\%$ lower confidence limit, $\hat{R}^{*(\alpha)}$, according to equation (2.13) for representative values of alpha and store each estimate in a vector array of estimates. Alpha values used in this study were 0.20, 0.10, and 0.05.

Step Five: Repeat Steps Two through Four until the three vector arrays of estimates corresponding to the three

different alpha values are 1000 values in length.

Step Six: Order the elements of each vector array from low to high and determine the sample mean and standard deviation.

Step Seven: Compute the true system reliability, R_s , from the input component reliabilities.

Step Eight: Extract the $100(1-\alpha)$ percentile value from the corresponding array and compare with the true system reliability. If the estimation procedure is accurate these two values should agree. If agreement does not occur, the differences should be small, preferably conservative, and, hopefully, can be made to converge toward zero.

Step Nine: Output all data which was input in Step One in order to insure against input error. Output starting and ending random number generator seed values. Output true system reliability, $100(1-\alpha)$ percentile values, differences from true reliability, sample means and standard deviations, and various percentile values of interest. Provision is made in the program for output of all of the sample values both before and after ordering, if the user desires.

Step Four was performed in two different ways for four of the cases where there was a high frequency of runs without failures, called 'null runs' in the output. The normal way of handling this problem was to discard that run data and repeat it from step one. Thus the complete arrays contained estimates from only those runs which had sufficient failures for the procedure to be valid without the special circumstances modification discussed in Section II.C. In order to observe the effect of utilizing the modification, however, cases 18 through 21 were repeated as cases 30 through 33 with the alternate procedure invoked

whenever \hat{S} equalled zero at the end of step three.

Three proprietary routines were utilized in the program and are therefore not reproduced in the program listing. These routines were used to obtain the binomially distributed random variables, the chi-square function values, and to sort the estimate arrays [Ref. 4].

B. DESCRIPTION OF THE CASES

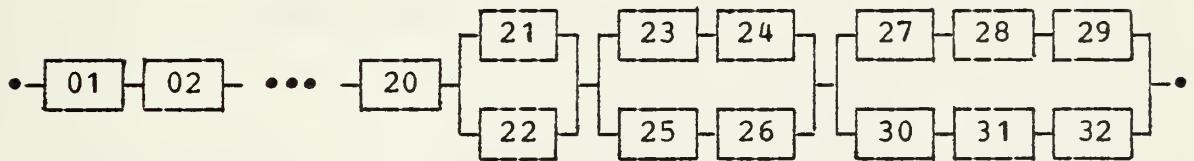
1. General

The cases chosen for simulation represent three different configurations; a series of components connected in series with a series of simple series-parallel subassemblies of components, a strictly series-connected system of components, and a system which incorporates two somewhat unusual but representative "real-world" subassembly reliability relationships. The first configuration was chosen to demonstrate the general performance of the revised estimation procedure with a moderately complex, series-parallel system. The second configuration consisted primarily of some cases which had previously been investigated for the original Log-gamma procedure [Ref. 1]. Since the revised procedure varied somewhat from the originally developed version in the treatment of the wholly series system, a comparison was desirable in order to ascertain whether significant effects had occurred in the procedure accuracy. The third configuration was chosen to observe the robustness of the procedure when applied to a much more complex system which is not easily reducible to a simpler series-parallel reliability representation.

In general, the simulated number of tests was the same for each component within each case. However, this number was varied among cases with the same true system reliability in order to identify its effect upon the procedure accuracy. The two exceptions were case 13 wherein the number of tests varied from component to component and case 14 for which only one value of simulated component tests was used without any corresponding cases with different numbers of tests.

2. Cases One Through Twelve

a. Reliability Block Diagram



b. Test Parameters

(1) Number of Component Tests, Ni.

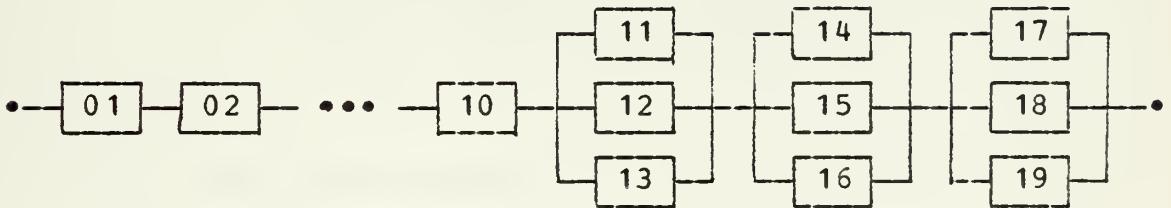
<u>Cases</u>	<u>Ni</u>
01, 04, 07, 10	20 i=1,2,...,32
02, 05, 08, 11	50 i=1,2,...,32
03, 06, 09, 12	100 i=1,2,...,32

(2) True System and Component Reliabilities, R_S and R_i .

<u>Cases</u>	<u>R_S</u>	<u>R_i</u>
01, 02, 03	.87559	{ .995 $i=1, 2, \dots, 20$.950 $i=21, \dots, 32$
04, 05, 06	.79984	{ .995 $i=1, 2, \dots, 20$.900 $i=21, \dots, 32$
07, 08, 09	.79167	{ .990 $i=1, 2, \dots, 20$.950 $i=21, \dots, 32$
10, 11, 12	.72317	{ .990 $i=1, 2, \dots, 20$.900 $i=21, \dots, 32$

3. Case Thirteen

a. Reliability Block Diagram



b. Test Parameters

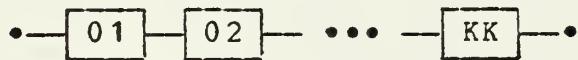
<u>i</u>	<u>N_i</u>	<u>R_i</u>	<u>i</u>	<u>N_i</u>	<u>R_i</u>	<u>i</u>	<u>N_i</u>	<u>R_i</u>
1	150	.995	7	28	.967	13	59	.682
2	90	.985	8	125	.995	14	5	.729
3	75	.979	9	63	.970	15	5	.729
4	100	.988	10	125	.995	16	5	.729
5	125	.982	11	59	.682	17	19	.536
6	18	.980	12	59	.682	18	19	.536
Rs: 0.72329								

c. Discussion

This case corresponds to Case No. 1 of reference 1. The only change was to replace the last three components each with three components in parallel with a subsystem reliability equivalent to the reliability of the replaced component.

4. Cases Fourteen Through Twenty-one and Thirty Through Thirty-three

a. Reliability Block Diagram



b. Test Parameters

(1) Number of Component Tests, Ni.

<u>Cases</u>	<u>Ni</u>
14	20 i=1,2,...,15
15, 18, 30	25 i=1,2,...,25
16, 17, 31	50 i=1,2,...,25
17, 20, 32	100 i=1,2,...,25
21, 33	200 i=1,2,...,25

(2) True System and Component Reliabilities, Rs
and Ri.

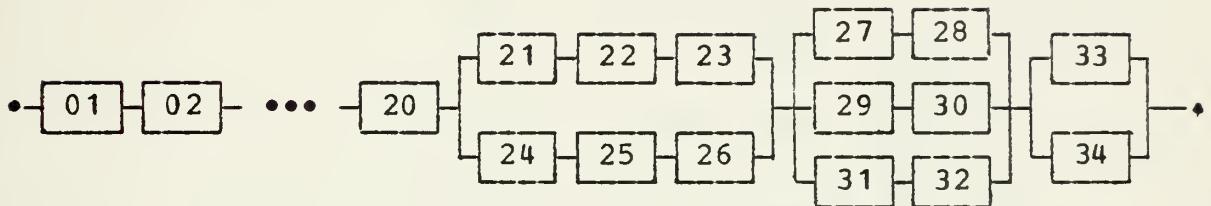
<u>Cases</u>	<u>Rs</u>	<u>Ri</u>
14	.79239	$\begin{cases} .995 & i=1, 2, \dots, 14 \\ .850 & i=15 \end{cases}$
15, 16, 17	.88222	.995 i=1, 2, ..., 25
18, 19, 20, 21]	.97530	.999 i=1, 2, ..., 25
30, 31, 32, 33]		

c. Discussion

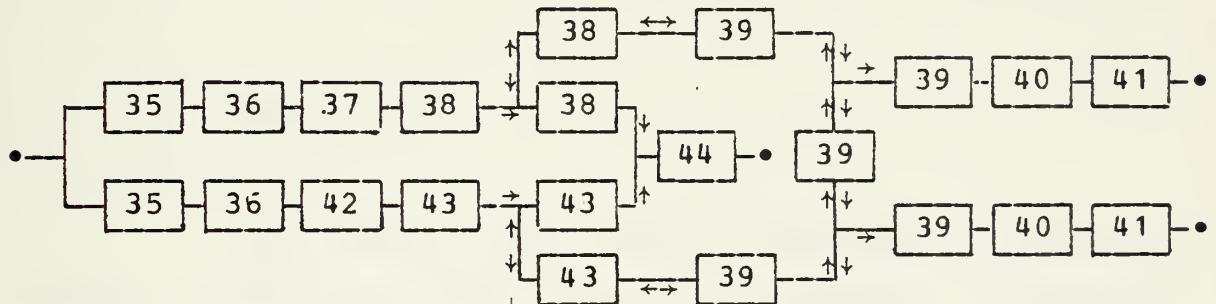
These cases correspond to several cases from Ref. 1 with the exception of cases 21 and 33 of the present study. These were added when it was noted that a large number of runs with zero failures were being observed with as many as 100 tests on each component. Cases 30 through 33 are identical with cases 18 through 21. They are identified as separate cases, since a slightly different procedure, as described in section III.A, was followed in their simulation.

5. Cases Twenty-two Through Twenty-nine

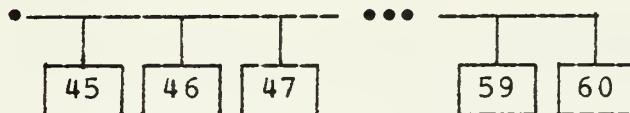
a. Reliability Block Diagram



In logical series with



In logical series with



b. Test Parameters

(1) Number of Component Tests, Ni.

<u>Cases</u>	<u>Ni</u>
22, 26	20 $i=1, 2, \dots, 60$
23, 27	25 $i=1, 2, \dots, 60$
24, 28	50 $i=1, 2, \dots, 60$
25, 29	100 $i=1, 2, \dots, 60$

(2) True System and Component Reliabilities, Rs and Ri.

<u>Cases</u>	<u>Rs</u>	<u>Ri</u>
22 through 29	(See below)	$\begin{cases} .999 & i=1,2,\dots,26 \\ .886 & i=27,28,\dots,32 \\ .900 & i=33,34 \\ .999 & i=35,36,\dots,41 \\ .990 & i=42,43,44 \end{cases}$
22 to 25	.87306 (.995) ^j	$\begin{cases} j=i-44 & \\ i=45,46,\dots,60 & \end{cases}$
26 to 29	.83293 (.990) ^j	$\begin{cases} j=i-44 & \\ i=45,46,\dots,60 & \end{cases}$

c. Discussion

The second and third subassembly reliability diagrams above were drawn from the Lockheed Reliability Evaluation Plan for the Trident Missile [Ref. 3].

In the second diagram, component 44 and both components 41 must operate successfully for system success. An additional feature of this design is the capability of obtaining successful functioning of component 44 by following a logical path through component 39 and continuing in a reverse direction to reach component 44 from the opposite side of the diagram, if necessary. This capability is illustrated with double arrows to indicate that the logical success path may be traced in either direction for that portion of the reliability diagram. Note also that identically numbered components are, in fact, separate components but identical in operation. Therefore, component test results for a particular component type are assumed to be equally applicable to all components of that type, regardless of the specific application. The reliability

equation for this portion of the diagram, as adapted from reference 3, is as follows:

$$\begin{aligned}
 R_{SS} = & M_4 \left[T_1 T_2 T_3 L_3 M_3 [1 - (1-M_1)(1-L_2 M_2)] \right. \\
 & + (1-T_1) L_1 L_2 L_3 T_3 M_3 [1 - (1-M_2)(1-T_2 M_1)] \left. \right] \\
 & + (1-M_4) \left[M_1 M_2 M_3 T_2 T_3 L_2 L_3 [1 - (1-T_1)(1-L_1)] \right. \\
 & + (1-M_1) M_2 M_3 T_1 T_2 T_3 L_1 L_2 L_3 \\
 & \left. \left. + (1-M_2) M_1 M_3 T_1 T_2 T_3 L_1 L_2 L_3 \right] \right] \quad (3.1)
 \end{aligned}$$

where

$T_1 = R_{35} R_{36} R_{37} R_{38}$	$M_1 = R_{38}$
$T_2 = R_{38} R_{39}$	$M_2 = R_{43}$
$T_3 = R_{39} R_{40} R_{41}$	$M_3 = R_{44}$
$L_1 = R_{35} R_{36} R_{42} R_{43}$	$M_4 = R_{39}$
$L_2 = R_{43} R_{39}$	$L_3 = T_3$

The third subassembly diagram illustrates another type of reliability problem in that the subassembly reliability is defined in Ref. 3 as follows:

$$R_{SS} = \frac{\sum_{i=45}^{60} R_i}{16}$$

Although these diagrams represent current systems, the reliability values chosen bear no intentional relation to actual values other than that acquired when choosing them on a criteria of reasonableness. Therefore the values used are not classified.

IV. RESULTS AND CONCLUSIONS

A. SIMULATION RESULTS

The simulation output is listed in detail in Appendix D for each run. Each case was simulated three times with different random number generator seed values to insure against the occurrence of non-representative singularities in the observed data. Each simulation is distinguished by a letter suffix, a, b, or c, to the case number in Appendix D. The starting seed used each time was the ending seed value from the previous run. This insured that each run would be independent [Ref. 5].

The demonstrated accuracy of the estimation procedure can be measured in terms of the difference between the $100(1-\alpha)$ percentile of the simulation results, $\hat{R}^{\ast 0}$, and the true system reliability, R_s . This difference, labeled D in the output tables, is defined as follows:

$$D = \hat{R}^{\ast 0} - R_s \quad (4.1)$$

As mentioned in Section III.A, the absolute value of D should be small and reflect a conservative error. This desired conservatism is satisfied so long as the sign of D is negative. Otherwise the lower confidence limit estimation procedure would yield overly-optimistic estimates and could not be a valid vehicle for the description of system reliability. The one instance where this condition was not satisfied occurred in Case 13c. However, the value of D was extremely small, represented less than one-half of

one percent error, and differed from the conservative results of the other runs by less than one percent.

It should also be noted that the distributions of the estimates \hat{t}_i , \hat{S} , and \hat{r} are discrete in nature and the values are determined by the number and arrangement of components and the number of component tests. Estimates based upon few failures will exhibit the most highly discrete sample distribution scheme. The effect of this discreteness will generally be to increase the observed error magnitude unless some form of continuity correction can be developed.

B. ANALYSIS OF RESULTS

1. General Characteristics

The simulation output for Cases One through Twelve was expanded to include the complete ordered arrays of estimated confidence limit values in order to establish the nature of the sample. Some properties were evident from inspection. The samples were unimodal and discrete, as expected. Discreteness was most pronounced in the higher valued estimates. The sample distribution appeared nearly symmetric and this supposition was checked by comparing the sample mean and median values and also by plotting complementary quantiles. The first test showed very close agreement throughout. The second test indicated that only minor left skewness exists in most cases. Skewness seemed more pronounced for higher values of system reliability, as might be expected might be suspected, since the distribution is bounded by an upper estimate value of 1.0.

The shape of the distribution was further described

by examining the ratio of the interquartile range divided by the interdecile range and comparing it with the same ratio from the Normal distribution which is about 0.526. The observed values were generally on the order of 0.50 which is in good agreement considering the discrete nature of the sample distribution. Systems designed with high reliability coupled with insufficient testing, such as Cases 18 and 19, exhibited great variations in the ratio, from 0.2 to 1.0, due to the sparcity of different sample values occurring in the pronouncedly discrete sample distribution.

Another useful measure of shape is the sample standard deviation. It is particularly helpful in quantifying the spread of the data in terms of the units of measure. The preceding ratio, on the other hand, was independent of the units. The sample standard deviation, however, gives no indication of skewness nor the discreteness of the underlying distribution. The standard deviation is most useful when these higher order effects are small.

The ability to predict the standard deviation from the test plan and system design parameters would provide an additional measure of the system reliability. This concept evolves from a consideration of the $100(1-\alpha)$ percent lower confidence limit. Of itself, it tells us only that there is a $(1-\alpha)$ probability that the true system reliability is greater than a particular value. The standard deviation of the estimate of this confidence limit can provide a feel for how much the true system reliability might vary from the estimate. For example, given an eighty percent lower confidence limit of 0.78 and a predicted standard deviation of the estimate of 0.005, we can feel fairly certain that the true system reliability does not exceed 0.82. However, had the standard deviation been 0.01 or 0.02, there would be increasing uncertainty about the range of likely values of

true reliability. Therefore, the sample standard deviation has been included in the regression section later in this chapter in an effort to not only predict procedure accuracy, but also estimate spread.

2. Derivation and Discussion of TT

Previous tests of the original Log-Gamma procedure have indicated that the quantity

$$TT = \sum_{i=1}^k (N_i) (Q_i) \quad (4.2)$$

could be used as an indicator of relative accuracy of the procedure, where N_i is the number of mission tests performed upon the i -th component and Q_i is the design or expected unreliability goal for the i -th component [Ref. 1]. The quantity determined in this manner was the total amount of testing relative to the component unreliabilities, or, approximately, the expected number of test failures summed over all components and tests.

A similiar measure was sought for the revised procedure examined in this paper. However, a simple expression, such as equation (4.2), could not be directly applied to the mixed series-parallel system. If the equation were used, it could lead to extremely large values of TT, since the parallel components would tend to dominate the sum. This is reasonable to expect, since the components connected in parallel, taken individually, would tend to have greater unreliability than the series components.

The first revised equation proposed for TT can be used whenever all components within each parallel subsystem are given identical numbers of mission tests.

$$TT = \sum_{i=1}^{K_1} (N_i) (Q_i) + \sum_{i=K_1+1}^{K_1+K_2} (N'_i) (Q'_i) \quad (4.3)$$

where K_1 is the number of series components in the system

K_2 is the number of series-parallel subassemblies connected in logical series in the system

N_i , Q_i are defined as above.

N'_i is the common number of tests given each component in the i -th subassembly.

Q'_i is the unreliability of the i -th subassembly computed from its component unreliability goals using standard series-parallel reliability computation techniques.

Equation (4.3), in effect, reduces each subassembly to an equivalent 'pseudo-component' connected in series in the system. The quantity TT is now approximately equal to the expected number of system-affecting failures summed over all components, subassemblies, and tests. However, the drawback of this equation is the necessity of testing all components within a subassembly an identical number of times. It would seem unnecessarily restrictive to conduct the same number of tests on a medium reliability component and on a high reliability component just to satisfy the equation.

Therefore an alternate formulation for the term $(N'_i) (Q'_i)$ was sought which would provide a meaningful measure, and yet would allow unequal amounts of testing within subassemblies. The following ad hoc formulation is proposed:

Each wholly series-connected branch within a subsystem will first be reduced to an equivalent single component by the following formula

$$Nb = \frac{\sum_{i \in B} (N_i) (1-R_i)}{1 - R_b} \quad (4.4)$$

where R_b is the classically determined branch reliability goal $R_b = \prod_{i \in B} R_i$ for series-connected components.

R_i is the reliability goal of the i -th component.

B is the set of all components in the branch.

N_b represents an "equivalent" number of branch tests (need not be integer).

The series-connected branch is replaced in the remaining computations by a single equivalent component with reliability goal $R_i = R_b$ and number of mission tests $N_i = N_b$.

After all wholly series-connected branches have been reduced in this manner, each wholly parallel-connected branch in the revised subassembly is reduced to an equivalent component in the following manner:

Compute the equivalent reliability goal

$$R_b = 1 - \prod_{i \in B} (1 - R_i)$$

in the usual manner.

The number of possible combinations of individual test results for the branch components is $\prod_{i \in B} N_i$, which is set equal to the same number of possible combinations obtained if each component had been tested N_b times. Thus the equivalent number of mission tests, N_b , is computed as the geometric mean of the component tests

$$N_b = \left[\prod_{i \in B} N_i \right]^{1/m}$$

The above procedure is repeated until the entire subassembly is reduced to a single equivalent component, i',

with its equivalent number of mission trials, N_i' , and equivalent unreliability goal, $Q_i' = 1 - R_i'$. TT may then be computed as before:

$$TT = \sum_{i=1}^{K_1} (N_i) (Q_i) + \sum_{i=K_1+1}^{K_1+K_2} (N_i') (Q_i') \quad (4.3)$$

3. Accuracy Prediction

Appendix E contains the equations and methodology used to attempt to relate the accuracy measure, D, and the estimate standard deviation to the quantity TT. The principal conclusion to be drawn from the results is that accuracy is a predictable quantity only with respect to particular system configurations for which models have been generated and tested as in this paper. Accuracy seems an unstable variable from configuration to configuration, although it appears to be fairly well behaved within any one configuration.

With respect to the estimate standard deviation, the value appears to be related more to the number of component tests than to the expected number of system affecting failures. Reduction in the magnitude of the standard deviation by about 0.01 appears to require almost double the number of component tests. However, the magnitudes are generally less than 0.07 for component test sample sizes of 20 or more. The standard deviation values also appear to be fairly insensitive to changes in system configuration.

4. Comparison with Earlier Results.

Cases 13 through 20 were taken from Ref. 1 in order to provide a basis for checking relative accuracy when

extending the Log-gamma procedure beyond simple series systems. Unfortunately, an apparent shortcoming of the original simulation makes the 1968 data suspect.

The original results tended to be too optimistic for those cases, in particular, where the number of component tests was moderately low and the true component reliabilities were high. Significantly high estimates at the $100(1-\alpha)$ percentile were observed in the cases corresponding to Cases 13, 15, 18, 19, and 20 of the present study. Although, on this basis, the comparison is very favorable to the present procedure, it is thought that the original simulation results are in error with respect to the procedure. Reference 1 does not specifically identify the random number generator used, however some uniform random variate generators do not perform well for very small or very large numbers near the boundaries, such as would be encountered in the simulation procedure used in the original study. The present simulation binomial random variate generator was tested prior to use to insure proper performance throughout the range of simulation values used.

Of the remaining cases (14, 16, and 17) the original results were much closer to the true system reliability in the first two cases and comparable in the last case. However, these results cannot be considered meaningful in light of the suspected problems with the random number generator.

In addition, many instances of cases found in Ref. 1 had prima-facia unreasonable results for the $100(1-\alpha)$ percentile values, in that they were considerably higher than the upper bound imposed by the zero-failure, binomial system test treatment discussed in Appendix C.

Another difference between the original study and

the present one is the use of an arbitrary continuity correction in the earlier procedure. This could also have been a contributor to the excess optimism in the reported simulation results.

In light of the foregoing paragraphs, no comparison with the results of this study was deemed worthwhile.

C. CONCLUSIONS

The primary conclusion to be drawn from this study is that the Log-gamma lower confidence level procedure for series-parallel systems can be accurate. How accurate it will be in any specific application is a function of the magnitude of the component testing program, the individual component reliabilities, and the complexity of the system. In addition, of course, the validity of the assumptions concerning component interaction and mission environment will also bear directly upon the accuracy of any procedure which purports to estimate system mission reliability from component test results. The effects of these assumptions, however will be controlled by the proper design of the component test procedures and are not addressed in this study.

For the cases considered the Log-gamma procedure tends to be conservative, which is necessary if one takes the position that pleasant surprises with better than expected performance cost less than unpleasant surprises in the form of degraded demonstrated reliability. Of course, too much underestimation of system reliability could drive up the development costs in an unnecessary search for a much more reliable design.

The accuracy indicator TT developed in Section IV.B.2 can be used as a rough gauge of expected procedure accuracy. The following scheme is suggested for minimum values of TT for fairly good expected accuracy:

Approximate Order of Accuracy	$\alpha = 0.20$	$\alpha = 0.10$	$\alpha = 0.05$
0.02	6.1	12.8	19.2
0.01	11.7	23.6	32.6

However, since procedure accuracy¹ is so demonstrably sensitive to variation in the system configuration, the best approach prior to use of the Log-gamma procedure is to perform a simulation as described in Section III.A for the particular system design to be exercised. Such a simulation could be used to evaluate many different combinations of component test plans and also support the claimed accuracy of the lower confidence limit derived from the adopted test plan results. The investment in such a simulation effort should not be excessive from the standpoint of computer time, since the most complex cases examined in this study required less than five minutes of Central Processor Unit (CPU) time from start to end. Without the support of such a simulation specific to the system, the accuracy of the procedure can be predicted only very approximately.

For extremely reliable systems, for which few failures are expected with large amounts of testing, the binomial lower confidence limit procedure developed in Appendix C might provide the desired magnitude of the lower confidence limit without the extra testing required to achieve the desired accuracy of the Log-gamma procedure. In fact, for cases of one failure or less, the binomial procedure is probably preferable on the basis of both theoretical rigor and ease of computation.

Finally, the matter of a continuity correction should be investigated. An appropriately determined continuity correction procedure could conceivably reduce the component testing requirements for the same expected procedure accuracy.

APPENDIX A

DERIVATION OF UNBIASED ESTIMATE FOR T_i

For

$$T_i = Q_i + Q_i^2/2$$

an unbiased estimator is desired, based upon the component failure data. Let F_i be the number of failures observed in N_i mission tests on the i -th component. The expected value of F_i is $N_i Q_i$ and an unbiased estimator, \hat{Q}_i , for Q_i is F_i/N_i , where F_i is binomially distributed with parameters Q_i and N_i ; $Q_i = 1 - R_i$; and R_i is the true reliability of the i -th component.

An estimator, \hat{T}_i , for T_i will be chosen of the form

$$\hat{T}_i = A_i[\hat{Q}_i] + B_i[\hat{Q}_i^2]/2 \quad (A.1)$$

and the constants A_i and B_i chosen so as to make the estimator unbiased, that is the expected value of T_i is equal to T_i ,

$$E[\hat{T}_i] = T_i = Q_i + Q_i^2/2 \quad (A.2)$$

$$\begin{aligned} &= A_i E[\hat{Q}_i] + (B_i/2) E[\hat{Q}_i^2] \\ &= (A_i/N_i) E[F_i] + (B_i/2N_i^2) E[F_i^2] \\ &= (A_i/N_i)[N_i Q_i] \\ &\quad + (B_i/2N_i^2)[N_i Q_i - N_i Q_i^2 + N_i^2 Q_i^2] \\ &= A_i Q_i + B_i Q_i/2N_i - B_i Q_i^2/2N_i + B_i Q_i^2/2 \\ &= [A_i + B_i/2N_i] Q_i + [B_i/2 - B_i/2N_i] Q_i^2 \quad (A.3) \end{aligned}$$

Equating equation (A.3) term by term with equation (A.2)
yields the following two equations

$$Ai + Bi/2Ni = 1$$

and $Bi - Bi/Ni = 1$

which reduce to expressions for the unbiased estimator
constants:

$$Ai = (2Ni-3)/(2Ni-2) \quad (A.4)$$

and $Bi = Ni/(Ni-1) \quad (A.5)$

APPENDIX B

APPROXIMATION OF $\text{Var}[\hat{T}_i]$ BY T_i/N_i

A. DERIVATION OF $\text{Var}[\hat{T}_i]$

The variance of \hat{T}_i is derived as follows:

From appendix A,

$$\hat{T}_i = A_i \hat{Q}_i + (B_i \hat{Q}_i^2)/2 \quad (\text{B.1})$$

$$\text{thus, } \hat{T}_i^2 = A_i^2 \hat{Q}_i^2 + A_i B_i \hat{Q}_i^3 + (B_i^2 \hat{Q}_i^4)/4 \quad (\text{B.2})$$

$$\text{Var}[\hat{T}_i] = E[\hat{T}_i^2] - E^2[\hat{T}_i] \quad (\text{B.3})$$

$$\begin{aligned} &= E[\hat{T}_i^2] - T_i^2 \\ &= (A_i^2/N_i^2) E[F_i^2] + (A_i B_i/N_i^3) E[F_i^3] \\ &\quad + (B_i^2/4N_i^4) E[F_i^4] \\ &\quad - [Q_i^2 + Q_i^3 + (Q_i^4/4)] \end{aligned} \quad (\text{B.4})$$

Using the moment generating functions for the binomially distributed variable F_i , with parameters Q_i and N_i , yields

$$E[F_i] = N_i Q_i \quad (\text{B.5})$$

$$E[F_i^2] = N_i Q_i + N_i Q_i^2 (N_i - 1) \quad (\text{B.6})$$

$$E[F_i^3] = N_i Q_i + N_i Q_i^2 (N_i - 1) [3 + Q_i (N_i - 2)] \quad (\text{B.7})$$

$$\begin{aligned} E[F_i^4] &= N_i Q_i^4 (N_i - 1) (N_i - 2) (N_i - 3) + 7 N_i Q_i^2 (N_i - 1) \\ &\quad + 6 N_i Q_i^3 (N_i - 1) (N_i - 2) + N_i Q_i \end{aligned} \quad (\text{B.8})$$

Substituting the moment equations (B.5) through (B.8) into equation (B.4) and simplifying the resulting expression yields the following equation for the variance of \hat{T}_i :

$$\begin{aligned} \text{Var}[\hat{T}_i] &= \frac{4N_i^2 - 3N_i + 1}{4N_i(N_i-1)^2} Q_i + \frac{3N_i - 4}{2N_i(N_i-1)} Q_i^2 \\ &\quad - \frac{1}{N_i-1} Q_i^3 - \frac{2N_i - 3}{2N_i(N_i-1)} Q_i^4 \end{aligned} \quad (\text{B.9})$$

or, in terms of A_i , B_i , N_i , and Q_i :

$$\begin{aligned} \text{Var}[\hat{T}_i] &= \frac{B_i^2 + 2N_i^2 B_i (A_i + B_i)}{4N_i^3} Q_i + \frac{2A_i + 1}{2N_i} Q_i^2 \\ &\quad - \frac{B_i}{N_i} Q_i^3 - \frac{A_i}{N_i} Q_i^4 \end{aligned} \quad (\text{B.10})$$

To test the approximation of $\text{Var}[\hat{T}_i]$ by T_i/N_i , equation (B.9) was solved with representative values of Q_i and N_i and compared with $E[\hat{T}_i]/N_i$. The percent error of the approximation was computed for each value and is given in table B-1. As expected, increasing N_i or decreasing Q_i improves the accuracy of the approximation.

By way of comparison, table B-2 shows the relative accuracy of this same approximation when T_i is defined as the first three, vice two, terms of the logarithmic series expansion of S [Eq. (2.3)]. In this case the unbiased estimator for T_i will be

$$\hat{T}_i = A'_i Q_i + B'_i Q_i^2/2 + C'_i Q_i^3/3 \quad (\text{B.11})$$

where

$$A'_i = \frac{6(N_i-1)(N_i-2)-3(N_i-4)-2}{6(N_i-1)(N_i-2)}$$

$$B'_i = \frac{N_i(N_i-4)}{(N_i-1)(N_i-2)}$$

$$C'_i = \frac{N_i^2}{(N_i-1)(N_i-2)}$$

Q_i	$N_i = 10$	$N_i = 50$	$N_i = 100$
0.001	-5.08%	-1.10%	-0.60%
0.003	-5.25%	-1.29%	-0.79%
0.006	-5.52%	-1.58%	-1.09%
0.01	-5.87%	-1.96%	-1.47%
0.03	-7.50%	-3.73%	-3.26%
0.06	-9.64%	-6.07%	-5.62%
0.10	-12.0%	-8.65%	-8.23%
0.20	-15.8%	-12.9%	-12.5%
0.30	-17.0%	-14.4%	-14.1%
0.40	-15.8%	-13.4%	-13.1%
0.50	-12.0%	-9.67%	-9.38%
0.60	-4.77%	-2.40%	-2.11%
0.70	+7.70%	+10.3%	+10.6%

Table B-1. Error Percentage of approximation for $\text{Var}[\hat{T}_i]$ Using Two-term Form of T_i .

Q_i	$N_i = 10$	$N_i = 50$	$N_i = 100$
0.001	-0.06%	-0.05%	-0.05%
0.003	-0.17%	-0.15%	-0.15%
0.006	-0.33%	-0.31%	-0.30%
0.01	-0.56%	-0.51%	-0.51%
0.03	-1.68%	-1.54%	-1.53%
0.06	-3.36%	-3.09%	-3.06%
0.10	-5.57%	-5.11%	-5.06%

Table B-2. Error Percentage of approximation for $\text{Var}[\hat{T}_i]$ Using Three-term Form of T_i .

Due to time constraints and the general acceptability of the values noted in table B-1, the use of the more complex definition of T_i was left for future study. However, figure B-1 plots the accuracy as a function of Q_i , N_i , and form of T_i .

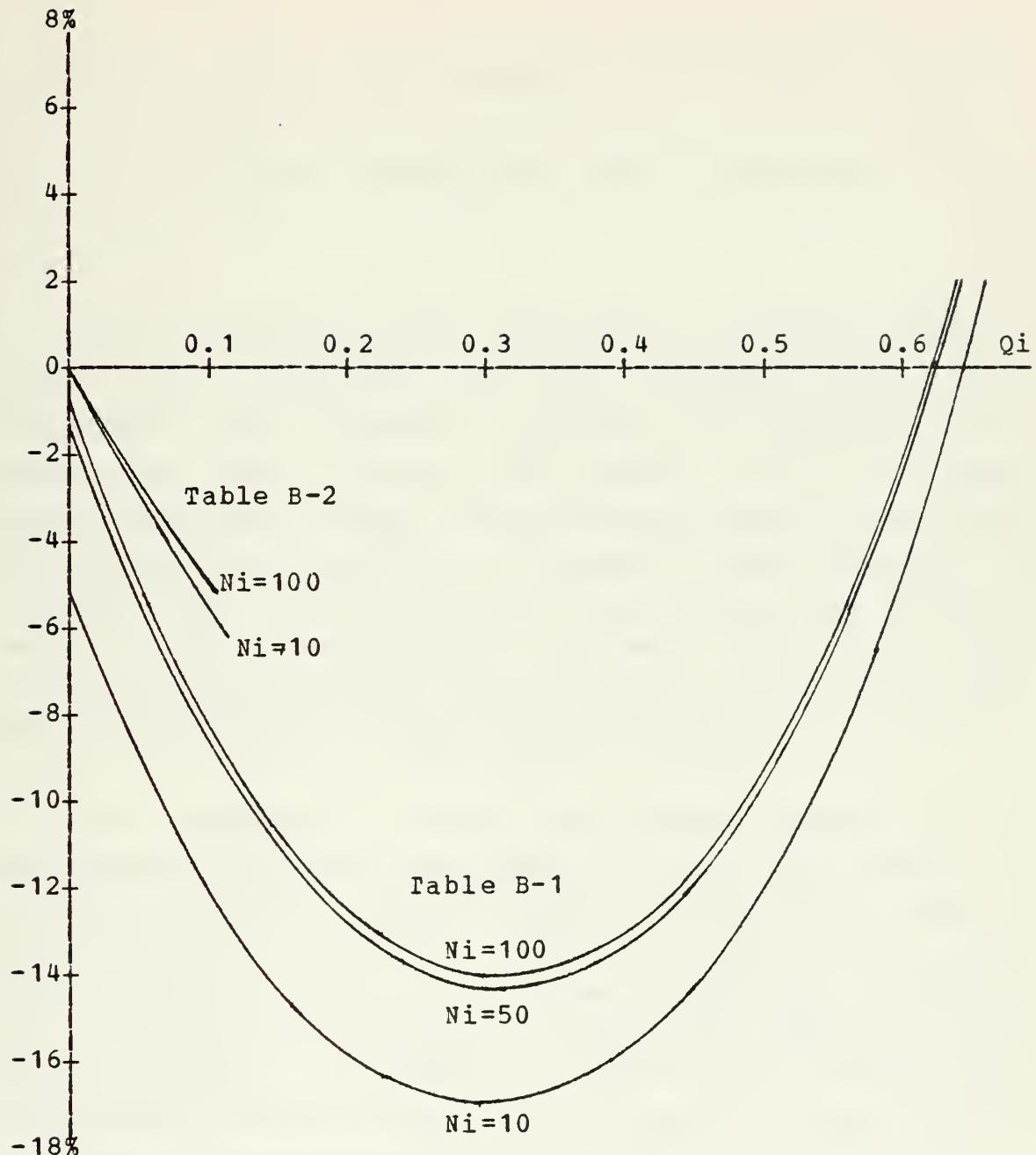


Figure B-1. PERCENTAGE ERROR OF APPROXIMATION FOR $\text{VAR}[\hat{T}_i]$
VS. COMPONENT UNRELIABILITY.

APPENDIX C

SPECIAL CONSIDERATIONS WHEN \hat{S} EQUALS ZERO

When all components have completed the course of mission tests and no failures have been observed along some reliability path through the system, the estimator \hat{S} will equal zero. This, in turn, will result in the log-gamma lower confidence limit estimate being equal to one unless the procedure is modified to include some "virtual" or "pseudo" test failure value for the computations when this occurs. The alternative is to seek some other lower confidence limit procedure which applies with zero failures. Such an alternative is also suggested below.

For simplicity, assume all series components and subassemblies have been subjected to an equal number of mission trials, N , without failure. This may be thought of as equivalent to conducting N mission trials on the system without failure, subject to the usual assumptions concerning test environment and component interaction effects. When unequal numbers of component trials are involved, the conservative course of action is to choose N equal to the smallest of the component trial values.

Now the number of system mission trial successes, W , can be related to system mission reliability, Rs , by the binomial distribution formula

$$\sum_{j=W}^N \binom{N}{j} (Rs)^j (1 - Rs)^{N-j} = \text{Prob}(\# \text{ successes} \geq W) \quad (\text{C.1})$$

where N = number of mission trials

The $100(1-\alpha)\%$ Lower Confidence Limit Estimate for system reliability would then be the solution for R^* in the following formula:

$$\sum_{j=W}^N \binom{N}{j} (R^*)^j (1 - R^*)^{N-j} = \alpha \quad (C.2)$$

which, when $W = N$, reduces to

$$(R^*)^N = \alpha \quad \text{or} \quad R^* = (\alpha)^{1/N}$$

This result may then be substituted into the Log-gamma procedure formula for $\hat{R}^*(\alpha)$ and solved for the number of equivalent component failures which would yield the same estimate of system reliability.

$$\hat{R}^*(\alpha) = \exp \left[\frac{-[2\hat{r}] \hat{S}}{\chi^2_{[2\hat{r}], 1-\alpha}} \right] = (\alpha)^{1/N} \quad (C.3)$$

where

$$\hat{S} = \sum_{i=1}^K \hat{T}_i \quad , \quad \hat{r} = \max \left[1.0, \frac{\left[\sum_{i=1}^K \hat{T}_i \right]^2}{\sum_{i=1}^K \frac{\hat{T}_i}{N_i}} \right]$$

which reduce to $\hat{S} = \hat{T}_i$ and $\hat{r} = \max[1, (N_i)(\hat{T}_i)]$, since only one component or subassembly will make a non-zero contribution to the sums.

Now, if $\hat{r} = 1.0$, then $(N_i)(\hat{T}_i) \leq 1.0$ and $\hat{T}_i \leq 1/N_i$. Also recall that

$$\hat{T}_i = (A_i)(\hat{Q}_i) + (B_i/2)(\hat{Q}_i^2) \quad (2.5)$$

where

$$A_i = \frac{2N_i - 3}{2(N_i - 1)} \quad , \quad B_i = \frac{N_i}{N_i - 1} \quad , \quad \hat{Q}_i = \frac{F_i}{N_i}$$

Or, equivalently,

$$(Bi/2Ni^2)(Fi^2) + (Ai/Ni)(Fi) - \hat{T}_i = 0 \quad (C.4)$$

Substituting for A_i , B_i and the earlier inequality for \hat{T}_i ,

$$\left[\frac{Ni}{2(Ni-1)(Ni^2)} \right] (Fi^2) + \left[\frac{2Ni-3}{2(Ni-1)(Ni)} \right] (Fi) - \frac{1}{Ni} \leq 0$$

which reduces to

$$Fi^2 + (2Ni-3)Fi - 2(Ni-1) \leq 0$$

which, in turn, can be factored as

$$(Fi - 1)[Fi + 2(Ni-1)] \leq 0 \quad (C.5)$$

The only positive values for Fi which can satisfy this last equation are Fi less than or equal to one. This means that for any size Ni , the value of $[2\hat{r}]$ will be two. We can now solve the reliability estimate equation for Fi^* , the number of equivalent failures for the Log-gamma method.

$$\exp \left[\frac{-[2\hat{r}] \hat{S}}{\chi^2_{[2\hat{r}], 1-\alpha}} \right] = (\alpha)^{1/N} \quad (C.6)$$

$$\hat{S} = \left[\frac{\chi^2_{2, 1-\alpha}}{2N} \right] (\ln \alpha) = \frac{Ai(Fi^*)}{N} + \frac{Bi(Fi^*)^2}{2N^2} \quad (C.7)$$

which reduces to

$$Fi^{*2} + (2N-3)Fi^* + (N-1)(\ln \alpha) \left[\chi^2_{2, 1-\alpha} \right] = 0 \quad (C.8)$$

This quadratic may be solved for Fi^* as a function of N and α . The results are listed in table C-1. From the table, choosing Fi^* at the $N = 10$ level will be conservative for all N greater than 10, yet will yield relatively accurate results for all larger N due to the slow rate of change of Fi^* with respect to N .

N	$\alpha=0.2$	$\alpha=0.1$	$\alpha=.05$
5	0.3888	0.2670	0.1713
10	0.3721	0.2531	0.1610
20	0.3652	0.2475	0.1570
100	0.3603	0.2435	0.1542
1000	0.3593	0.2427	0.1536

Table C-1. Solution for F_i^* with
Various N and α Values.

APPENDIX D

TABULATED SIMULATION RESULTS

The following pages contain two tables listing the principal simulation output data. The tables are presented concurrently for each case, one case per page. The cases are listed in alpha-numeric order. The following list of terms applies:

Case: The case number as explained in Section III.B. The letter suffix distinguishes between different runs of the same case using different seeds for the binomial random variate generating function.

KK: The total number of components in the system.

TT: The accuracy indicator as discussed in section IV.B.

TM: The modified accuracy indicator described in Appendix E.

RS: True system reliability.

CL: Confidence Level, $CL = 100(1-\alpha)$.

\hat{R}^* : The $100(1-\alpha)$ percentile of the simulation estimates of the $100(1-\alpha)\%$ lower confidence limit for system reliability.

D: The primary accuracy measure. As discussed in Section IV.A, $D = \hat{R}^* - RS$.

Mean: The sample mean of the estimates.

S.D.: The sample standard deviation of the estimates.

Null Runs: The number of runs which occurred during the simulation for which \hat{S} equalled zero. Refer to sections II.C and III.A and Appendix C for further elaboration.

Case	KK	TT	TM	RS	CL	\hat{R}^{*o}	D	Mean	S.D.
01a	32	2.67	1.73	0.8756	80..0	0.8206	-0.0550	0.7728	0.0668
					90..0	0.7452	-0.1304	0.6896	0.0608
					95..0	0.6457	-0.2299	0.5897	0.0586
01b	32	2.67	1.73	0.8756	80..0	0.8193	-0.0563	0.7727	0.0646
					90..0	0.7464	-0.1292	0.6892	0.0584
					95..0	0.6461	-0.2295	0.5894	0.0560
01c	32	2.67	1.73	0.8756	80..0	0.8235	-0.0521	0.7721	0.0706
					90..0	0.7500	-0.1256	0.6893	0.0652
					95..0	0.6551	-0.2205	0.5898	0.0624

Table D-1. Simulation Results.

Case	RS	Null Runs	CL	Minimum 10%	Lower Confidence Limit 25%	Median	Estimate 75%	Percentile 90%	Values Maximum
01a	0.87559	3	.80	.53944	.69032	.73043	.77577	.81214	.84858 .98884
			.90	.48173	.62211	.65534	.68976	.71470	.74522 .97652
01b	0.87559	2	.80	.58990	.69065	.73087	.77493	.81276	.84287 .98884
			.90	.52912	.62342	.65790	.68654	.71696	.74642 .97652
01c	0.87559	4	.80	.54338	.68722	.72971	.77453	.81283	.84552 .97779
			.90	.48590	.61906	.65396	.68826	.71614	.75094 .95352
			.95	.37693	.53220	.56440	.58946	.61321	.63796 .90680

Table D-2. Additional Simulation Output

Case	KK	TT	TM	RS	CL	$\hat{R}^{\text{*o}}$	D	Mean	S.D.
02a	32	6.68	4.33	0.8756	80.0	0.8609	-0.0147	0.8232	0.0442
					90.0	0.8416	-0.0340	0.7883	0.0434
					95.0	0.8127	-0.0629	0.7525	0.0407
02b	32	6.68	4.33	0.8756	80.0	0.8593	-0.0163	0.8220	0.0440
					90.0	0.8411	-0.0345	0.7871	0.0431
					95.0	0.8108	-0.0648	0.7512	0.0401
02c	32	6.68	4.33	0.8756	80.0	0.8581	-0.0175	0.8219	0.0419
					90.0	0.8382	-0.0374	0.7871	0.0413
					95.0	0.8079	-0.0677	0.7515	0.0388

Table D-1. Simulation Results (continued).

Case	RS	Null Runs	CL	Minimum	Lower Confidence Limit	Median	Percentile 75 %	Percentile 90 %	Values Maximum
02a	0.87559	0	.80	65891	76871	79558	82406	85334	87724 93761
			.90	62550	73444	76068	78970	81891	84163 89509
			.95	59525	70164	72700	75476	78227	80256 83969
02b	0.87559	0	.80	67925	76328	79249	82399	85253	87684 95942
			.90	64552	72870	75819	78935	81748	84113 91599
			.95	61468	69577	72474	75520	78037	80123 83924
02c	0.87559	0	.80	69563	76882	79494	82324	85206	87362 92467
			.90	66188	73484	76030	78868	81707	83819 88568
			.95	63083	70172	72656	75330	78017	79999 83678

Table D-2. Additional Simulation Output (continued)

Case	KK	TT	TM	RS	CL	\hat{R}^{*o}	D	Mean	S.D.
03a	32	13.4	8.67	0.8756	80.0	0.8691	-0.0065	0.8425	0.0325
					90.0	0.8628	-0.0128	0.8220	0.0330
					95.0	0.8535	-0.0221	0.8025	0.0329
03b	32	13.4	8.67	0.8756	80.0	0.8655	-0.0101	0.8392	0.0323
					90.0	0.8573	-0.0183	0.8187	0.0328
					95.0	0.8476	-0.0280	0.7991	0.0327
03c	32	13.4	8.67	0.8756	80.0	0.8678	-0.0078	0.8421	0.0314
					90.0	0.8603	-0.0153	0.8216	0.0319
					95.0	0.8520	-0.0236	0.8021	0.0319

Table D-1. Simulation Results (continued).

Case	RS	Null Runs	CL	Minimum	10 %	Confidence Limit	Median	Percentile 75 %	Percentile 90 %	Values	Maximum
03a	0.87559	0	.80	.75991	.80069	.82015	.84283	.86422	.88257	.93326	
			.90	.73837	.77952	.79940	.82246	.84404	.86278	.91309	
			.95	.71882	.75992	.77990	.80288	.82450	.84349	.89037	

Table D-2. Additional Simulation Output (continued)

Case	KK	TT	TM	RS	CL	\hat{R}^{*o}	D	Mean	S.D.
04a	32	4.59	2.97	0.7998	80.0	0.7555	-0.0443	0.6962	0.0680
				90.0	0.6988	-0.1010	0.6250	0.0596	
				95.0	0.6196	-0.1802	0.5506	0.0488	
04b	32	4.59	2.97	0.7998	80.0	0.7524	-0.0474	0.6948	0.0673
				90.0	0.6975	-0.1023	0.6247	0.0605	
				95.0	0.6200	-0.1798	0.5525	0.0501	
04c	32	4.59	2.97	0.7998	80.0	0.7544	-0.0454	0.6953	0.0664
				90.0	0.6956	-0.1042	0.6247	0.0588	
				95.0	0.6161	-0.1837	0.5515	0.0471	

Table D-1. Simulation Results (continued).

Case	RS	Null Runs	CL	Minimum 10 %	Lower Confidence Limit 25 %	Median	Estimate 75 %	Percentile 90 %	Values Maximum
04a	0.79984	0	80	48972	61041	65058	69590	74771	78197
			90	43625	54882	58596	62685	67005	69881
			95	38537	48419	52212	55678	58542	60847
04b	0.79984	0	80	44002	60848	65274	69752	74341	77654
			90	39024	54672	58755	62925	66842	69749
			95	34712	48617	52372	55975	58732	60935
04c	0.79984	0	80	47640	60950	65157	69646	74662	77755
			90	42249	54783	58604	62869	66911	69563
			95	37508	48818	52285	55888	58553	60642

Table D-2. Additional Simulation Output (continued)

Case	KK	TT	TM	RS	CL	\hat{R}^{eo}	D	Mean	S.D.
05a	32	11.5	7.43	0.7998	80.0	0.7839	-0.0159	0.7451	0.0450
					90.0	0.7689	-0.0309	0.7108	0.0448
					95.0	0.7458	-0.0541	0.6783	0.0437
05b	32	11.5	7.43	0.7998	80.0	0.7816	-0.0183	0.7449	0.0429
					90.0	0.7631	-0.0367	0.7106	0.0428
					95.0	0.7452	-0.0547	0.6781	0.0416
05c	32	11.5	7.43	0.7998	80.0	0.7832	-0.0167	0.7454	0.0464
					90.0	0.7696	-0.0302	0.7111	0.0461
					95.0	0.7460	-0.0538	0.6786	0.0450

Table D-1. Simulation Results (continued).

Case	RS	Null Runs	CL	Minimum	Lower Confidence Limit	Median	Percentile 75 %	Percentile 90 %	Maximum
05a	0.79984	0	.80	.59499	.68927	.71713	.74444	.77731	.86177
			.90	.56231	.65536	.68309	.71020	.74243	.82783
			.95	.53328	.62407	.65145	.67778	.70872	.79186
05b	0.79984	0	.80	.60950	.68998	.71483	.74415	.77564	.79795
			.90	.57666	.65578	.68059	.71000	.74129	.84399
			.95	.54698	.62435	.64876	.67767	.70816	.80112
05c	0.79984	0	.80	.54462	.68834	.71679	.74954	.77669	.80420
			.90	.51291	.65416	.68272	.71535	.74256	.82016
			.95	.48516	.62324	.65105	.68300	.70906	.73594

Table D-2. Additional Simulation Output (continued)

Case	KK	TT	TM	RS	CL	$\hat{R}^{\text{*o}}$	D	Mean	S.D.
06a	32	22.9	14.9	0.7998	80.0	0.7891	-0.0107	0.7625	0.0314
				90.0	0.7810	-0.0188	0.7409	0.0318	
				95.0	0.7716	-0.0282	0.7213	0.0317	
06b	32	22.9	14.9	0.7998	80.0	0.7886	-0.0113	0.7619	0.0320
				90.0	0.7828	-0.0170	0.7403	0.0322	
				95.0	0.7748	-0.0250	0.7207	0.0322	
06c	32	22.9	14.9	0.7998	80.0	0.7879	-0.0120	0.7613	0.0311
				90.0	0.7774	-0.0225	0.7397	0.0312	
				95.0	0.7702	-0.0297	0.7200	0.0312	

Table D-1. Simulation Results (continued).

Case	RS	Null Runs	CL	Minimum	Lower Confidence Limit	Median	Percentile 75 %	Percentile 90 %	Values Maximum
06a	0.79984	0	.80	.65710	.72329	.74237	.76278	.78275	.86406
			.90	.63521	.70147	.72061	.74120	.76129	.84358
			.95	.61595	.68192	.70099	.72156	.74159	.82429
06b	0.79984	0	.80	.64967	.72275	.74021	.76058	.78276	.84749
			.90	.62777	.70090	.71848	.73890	.76130	.82723
			.95	.60855	.68131	.69886	.71927	.74161	.80793
06c	0.79984	0	.80	.65784	.72172	.74177	.76064	.78345	.85272
			.90	.63582	.69981	.71998	.73895	.76205	.83260
			.95	.61643	.68017	.70032	.71931	.74241	.81336

Table D-2. Additional Simulation Output (continued)

Case	KK	TT	TM	RS	CL	\hat{R}^*o	D	Mean	S.D.
07a	32	4.67	3.03	0.7917	80.0	0.7557	-0.0359	0.6850	0.0807
				90.0	0.7012	-0.0904	0.6144	0.0715	
				95.0	0.6202	-0.1715	0.5406	0.0578	
07b	32	4.67	3.03	0.7917	80.0	0.7627	-0.0290	0.6883	0.0811
				90.0	0.7034	-0.0883	0.6176	0.0716	
				95.0	0.6254	-0.1663	0.5436	0.0572	
07c	32	4.67	3.03	0.7917	80.0	0.7503	-0.0414	0.6844	0.0773
				90.0	0.6996	-0.0921	0.6144	0.0687	
				95.0	0.6202	-0.1715	0.5419	0.0566	

Table D-1. Simulation Results (continued).

Case	RS	Null Runs	CL	Minimum 10 %	Lower Confidence Limit 25 %	Median	Estimate 75 %	Percentile 90 %	Values Maximum
07a	0.79167	0	.80	.44802	.58087	.63122	.68742	.73980	.79090 .95813
			.90	.39723	.52024	.56678	.61866	.66591	.70123 .91337
			.95	.35308	.46297	.50207	.54601	.58169	.60634 .83005
07b	0.79167	0	.80	.45284	.57832	.63451	.69260	.74744	.79082 .94593
			.90	.40095	.51803	.57087	.62358	.67360	.70336 .88892
			.95	.35576	.46283	.50859	.55297	.58580	.61029 .78501
07c	0.79167	0	.80	.38869	.58239	.63401	.68801	.73831	.78287 .97779
			.90	.34237	.52236	.56991	.61936	.66531	.69960 .95352
			.95	.30297	.46551	.50816	.54743	.58297	.60634 .90680

Table D-2. Additional Simulation Output (continued)

Case	KK	TT	TM	RS	CL	\hat{R}^{*o}	D	Mean	S.D.
08a	32	11.7	7.57	0.7917	80.0	0.7788	-0.0129	0.7368	0.0520
					90.0	0.7689	-0.0228	0.7026	0.0518
					95.0	0.7528	-0.0389	0.6702	0.0504
08b	32	11.7	7.57	0.7917	80.0	0.7777	-0.0140	0.7331	0.0541
					90.0	0.7694	-0.0222	0.6989	0.0537
					95.0	0.7551	-0.0365	0.6666	0.0524
08c	32	11.7	7.57	0.7917	80.0	0.7767	-0.0150	0.7327	0.0530
					90.0	0.7632	-0.0285	0.6986	0.0526
					95.0	0.7487	-0.0429	0.6663	0.0512

Table D-1. Simulation Results (continued).

Case	RS	Null Runs	CL	Minimum	10 %	Confidence Limit	Median	Percentile 75 %	90 %	Values Maximum
08a	0.79167	0	.80	.58162	.67194	.69966	.73759	.76997	.80417	.90349
			.90	.54914	.63828	.66556	.70304	.73573	.76888	.86814
			.95	.52041	.60763	.63410	.67082	.70297	.73495	.82644
08b	0.79167	0	.80	.57794	.66379	.69643	.73256	.76951	.80434	.89135
			.90	.54570	.63015	.66267	.69836	.73545	.76942	.85627
			.95	.51722	.59962	.63157	.66632	.70212	.73532	.81640
08c	0.79167	0	.80	.58949	.66094	.69694	.73291	.76725	.79764	.91141
			.90	.55696	.62707	.66308	.69875	.73315	.76332	.86608
			.95	.52813	.59640	.63194	.66673	.70036	.72952	.81783

Table D-2. Additional Simulation Output (continued)

Case	KK	TT	TM	RS	CL	\hat{R}^{*o}	D	Mean	S.D.
09a	32	23.4	15.1	0.7917	80.0	0.7871	-0.0046	0.7551	0.0383
					90.0	0.7817	-0.0100	0.7335	0.0386
					95.0	0.7764	-0.0152	0.7139	0.0385
09b	32	23.4	15.1	0.7917	80.0	0.7857	-0.0060	0.7542	0.0385
					90.0	0.7813	-0.0104	0.7326	0.0388
					95.0	0.7742	-0.0175	0.7130	0.0388
09c	32	23.4	15.1	0.7917	80.0	0.7839	-0.0078	0.7538	0.0383
					90.0	0.7819	-0.0098	0.7322	0.0385
					95.0	0.7755	-0.0162	0.7125	0.0385

Table D-1. Simulation Results (continued).

Case	RS	Null Runs	CL	Minimum 10 %	Lower Confidence Limit 25 %	Median	Estimate 75 %	Percentile 90 %	Values Maximum
09a	0.79167	0	.80	.63478	.70642	.72995	.75499	.78073	.80272 .86981
			.90	.61288	.68446	.70810	.73337	.75940	.78166 .84982
			.95	.59372	.66487	.68846	.71376	.73958	.76216 .83037
09b	0.79167	0	.80	.62609	.70625	.72913	.75489	.77990	.80230 .88091
			.90	.60430	.68427	.70722	.73326	.75852	.78128 .86134
			.95	.58526	.66467	.68754	.71365	.73892	.76175 .84203
09c	0.79167	0	.80	.61157	.70578	.72972	.75441	.77767	.80320 .86563
			.90	.58980	.68377	.70785	.73274	.75610	.78190 .84564
			.95	.57085	.66415	.68820	.71310	.73634	.76221 .82627

Table D-2. Additional Simulation Output (continued)

Case	KK	TT	TM	RS	CL	$\hat{R}^{\ast}o$	D	Mean	S.D.
10a	32	6.59	4.27	0.7232	80.0	0.6889	-0.0343	0.6233	0.0758
					90.0	0.6471	-0.0761	0.5597	0.0697
					95.0	0.5932	-0.1300	0.4983	0.0606
10b	32	6.59	4.27	0.7232	80.0	0.6897	-0.0335	0.6227	0.0800
					90.0	0.6544	-0.0688	0.5592	0.0736
					95.0	0.5985	-0.1247	0.4976	0.0636
10c	32	6.59	4.27	0.7232	80.0	0.6906	-0.0326	0.6340	0.0780
					90.0	0.6520	-0.0712	0.5602	0.0717
					95.0	0.5932	-0.1299	0.4984	0.0625

Table D-1. Simulation Results (continued).

Case	RS	Null Runs	CL	Lower Confidence Limit 10 %	Median 25 %	Estimate 50 %	Percentile 75 %	Percentile 90 %	Values Maximum
10a	0.72317	0	.80	.38169	.52320	.56765	.62362	.67774	.71491
			.90	.33622	.46646	.50850	.56045	.61015	.64708
			.95	.29763	.41592	.45525	.49977	.54475	.57482
10b	0.72317	0	.80	.40848	.51967	.56637	.61984	.67426	.72627
			.90	.36039	.46321	.50735	.55732	.60872	.65438
			.95	.31920	.41270	.45360	.49868	.54328	.57726
10c	0.72317	0	.80	.41254	.51980	.56890	.62469	.68110	.72407
			.90	.36448	.46295	.50943	.56162	.61399	.65197
			.95	.32326	.41345	.45571	.50127	.54580	.57756

Table D-2. Additional Simulation Output (continued)

Case	KK	TT	TM	RS	CL	\hat{R}^{*o}	D	Mean	S. D.
11a	32	16.5	10.7	0.7232	80.0	0.7099	-0.0132	0.6647	0.0520
					90.0	0.6953	-0.0279	0.6311	0.0514
					95.0	0.6779	-0.0453	0.6004	0.0502
11b	32	16.5	10.7	0.7232	80.0	0.7060	-0.0171	0.6636	0.0510
					90.0	0.6938	-0.0294	0.6300	0.0505
					95.0	0.6817	-0.0415	0.5994	0.0493
11c	32	16.5	10.7	0.7232	80.0	0.7115	-0.0116	0.6672	0.0525
					90.0	0.7011	-0.0220	0.6335	0.0520
					95.0	0.6843	-0.0389	0.6028	0.0508

Table D-1. Simulation Results (continued).

Case	Rs	Null Runs	CL	Minimum 10 %	Lower Confidence Limit 25 %	Median	Estimate 75 %	Percentile 90 %	Values Maximum
11a	0.72317	0	:80	:47279	:59689	:62798	:66587	:70222	:72980 :82596
			:90	:44301	:56430	:59476	:63212	:66834	:69533 :79100
			:95	:41741	:53534	:56494	:60167	:63701	:66304 :75559
11b	0.72317	0	:80	:48277	:59915	:63033	:66350	:69693	:72775 :84057
			:90	:45267	:56623	:59708	:62984	:66292	:69383 :80645
			:95	:42673	:53695	:56710	:59929	:63184	:66190 :77143
11c	0.72317	0	:80	:52162	:59916	:63076	:66657	:70357	:73559 :82379
			:90	:49048	:56624	:59752	:63266	:66908	:70114 :78845
			:95	:46339	:53696	:56769	:60180	:63763	:66848 :75267

Table D-2. Additional Simulation Output (continued)

Case	KK	TT	TM	RS	CL	\hat{R}^{*o}	D	Mean	S.D.
12a	32	32.9	21.4	0.7232	80.0	0.7151	-0.0081	0.6849	0.0358
					90.0	0.7096	-0.0136	0.6630	0.0358
					95.0	0.7019	-0.0213	0.6435	0.0356
12b	32	32.9	21.4	0.7232	80.0	0.7147	-0.0085	0.6845	0.0368
					90.0	0.7083	-0.0149	0.6627	0.0367
					95.0	0.7003	-0.0229	0.6433	0.0366
12c	32	32.9	21.4	0.7232	80.0	0.7165	-0.0067	0.6868	0.0362
					90.0	0.7120	-0.0112	0.6649	0.0363
					95.0	0.7045	-0.0187	0.6455	0.0360

Table D-1. Simulation Results (continued).

Case	RS	Null Runs	CL	Minimum	Lower 10 %	Confidence Limit 25 %	Median	Estimate 75 %	Percentile 90 %	Values	Maximum
12a	0.72317	0	:80	:59098	:63998	:66109	:68369	:70760	:73135	:80584	
		:90	:56944	:61814	:63921	:66167	:68570	:70958	:78478		
		:95	:55076	:59901	:61990	:64216	:66617	:69002	:76528		
12b	0.72317	0	:80	:55970	:63851	:66109	:68655	:71031	:73015	:78661	
		:90	:53843	:61662	:63915	:66439	:68836	:70831	:76518		
		:95	:52009	:59744	:61975	:64485	:66876	:68868	:74550		
12c	0.72317	0	:80	:58726	:64023	:66333	:68675	:70933	:73387	:79268	
		:90	:56573	:61830	:64138	:66470	:68732	:71203	:77146		
		:95	:54707	:59904	:62205	:64515	:66768	:69238	:75189		

Table D-2. Additional Simulation Output (continued)

Case	KK	TT	TW	RS	CL	\hat{R}^{*o}	D	Mean	S.D.
13a	19	15.4	10.7	0.7233	80.0	0.7195	-0.0038	0.6658	0.0647
					90.0	0.7176	-0.0057	0.6335	0.0662
					95.0	0.7119	-0.0114	0.6042	0.0672
13b	19	15.4	10.7	0.7233	80.0	0.7198	-0.0035	0.6676	0.0622
					90.0	0.7143	-0.0090	0.6354	0.0637
					95.0	0.7123	-0.0110	0.6060	0.0649
13c	19	15.4	10.7	0.7233	80.0	0.7263	+0.0030	0.6696	0.0680
					90.0	0.7264	+0.0031	0.6373	0.0696
					95.0	0.7257	+0.0024	0.6080	0.0707

Table D-1. Simulation Results (continued).

Case	RS	Null Runs	CL	Lower Confidence Limit 10 %	Median 25 %	Estimate Median	Percentile 75 %	90 %	Values Maximum
13a	0.72329	0	.80	.48075	.57589	.62474	.66831	.70837	.74695 : 85199
		.90	.44732	.54331	.59298	.63561	.67681	.71758	.82642 : 80113
		.95	.41620	.51302	.56258	.60410	.64881	.69143	
13b	0.72329	0	.80	.46207	.58839	.62658	.67098	.71049	.74397 : 85327
		.90	.42661	.55217	.59377	.63913	.67878	.71427	.82692 : 80068
		.95	.39601	.52107	.56404	.60892	.65022	.68551	
13c	0.72329	0	.80	.42256	.58572	.62423	.67044	.71730	.75410 : 85472
		.90	.38883	.55042	.58986	.63877	.68509	.72639	.82958 : 80087
		.95	.36002	.51810	.55940	.60920	.65589	.70087	.80469

Table D-2. Additional Simulation Output (continued)

Case	KK	TT	TM	RS	CL	$\hat{R}^{\star}o$	D	Mean	S.D.
14a	15	4.40	3.14	0.7924	80.0	0.7561	-0.0363	0.6903	0.0758
					90.0	0.6865	-0.1059	0.6163	0.0647
					95.0	0.6388	-0.1536	0.5375	0.0652
14b	15	4.40	3.14	0.7924	80.0	0.7561	-0.0363	0.6898	0.0776
					90.0	0.6865	-0.1059	0.6162	0.0669
					95.0	0.6388	-0.1536	0.5379	0.0665
14c	15	4.40	3.14	0.7924	80.0	0.7561	-0.0363	0.6890	0.0744
					90.0	0.6865	-0.1059	0.6162	0.0642
					95.0	0.6388	-0.1536	0.5394	0.0633

Table D-1. Simulation Results (continued).

Case	RS	Null Runs	CL	Minimum	Lower Confidence Limit 10 %	Median	Estimate 75 %	Percentile 90 %	Values Maximum
14a	0.79239	5	80	438820	58497	62901	69696	75814	79927 .80327
			:90	388840	:52379	:56639	:62751	:67696	:68654 :72709
			:95	:34527	:44252	:49880	:55675	:57773	:61078 .63884
14b	0.79239	9	80	40335	58721	62901	70586	75814	79927 .80327
			:90	:35524	:52621	:56639	:62751	:67696	:68654 :72709
			:95	:31410	:44252	:49880	:55675	:57773	:61078 .63884
14c	0.79239	10	80	42400	58497	62901	69696	74888	79927 .80327
			:90	:37505	:52379	:56639	:62751	:66470	:68654 :72709
			:95	:33289	:45711	:50391	:55675	:57659	:61078 .63884

Table D-2. Additional Simulation Output (continued)

Case	KK	TT	TM	RS	CL	\hat{R}^{*o}	D	Mean	S.D.
15a	25	3.12	2.09	0.8822	80.0	0.8236	-0.0586	0.7790	0.0535
					90.0	0.7402	-0.1420	0.6969	0.0392
					95.0	0.6455	-0.2367	0.5962	0.0696
15b	25	3.12	2.09	0.8822	80.0	0.8236	-0.0586	0.7795	0.0520
					90.0	0.7402	-0.1420	0.6997	0.0394
					95.0	0.6455	-0.2367	0.6030	0.0653
15c	25	3.12	2.09	0.8822	80.0	0.8236	-0.0586	0.7789	0.0536
					90.0	0.7402	-0.1420	0.6991	0.0407
					95.0	0.6455	-0.2367	0.6025	0.0651

Table D-1. Simulation Results (continued).

Case	RS	Null Runs	CL	Minimum	Lower Confidence Limit	Median	Percentile 75 %	90 %	Values Maximum
15a	0.88222	40	80	57786	69497	75679	79095	82358	83590
			90	52740	64006	68406	69292	72127	84003
			95	45815	45815	57625	62593	64372	76008
15b	0.88222	53	80	55247	69497	75679	79095	82358	83590
			90	50185	64006	68406	69292	74017	84003
			95	45625	45815	60180	62593	64372	76008
15c	0.88222	45	80	57525	69497	75679	79095	82358	83590
			90	52461	64006	68406	70531	74017	84003
			95	45815	45815	60180	63745	64372	76008

Table D-2. Additional Simulation Output (continued)

Case	KK	TT	TM	RS	CL	\hat{R}^{*o}	D	Mean	S.D.
16a	25	6.25	4.18	0.8822	80.0	0.8699	-0.0123	0.8285	0.0457
					90.0	0.8493	-0.0329	0.7923	0.0432
					95.0	0.8023	-0.0799	0.7540	0.0388
16b	25	6.25	4.18	0.8822	80.0	0.8699	-0.0123	0.8277	0.0461
					90.0	0.8493	-0.0329	0.7916	0.0437
					95.0	0.8023	-0.0799	0.7534	0.0392
16c	25	6.25	4.18	0.8822	80.0	0.8699	-0.0123	0.8278	0.0452
					90.0	0.8493	-0.0329	0.7914	0.0425
					95.0	0.8023	-0.0799	0.7527	0.0386

Table D-1. Simulation Results (continued).

Case	RS	Null Runs	CL	Minimum	Lower Confidence Limit	Median	Estimate	Percentile 75 %	Percentile 90 %	Values	Maximum
16a	0.88222	0	.80	.66422	.77665	.79675	.83156	.86994	.88935	.91737	
		.90	.63061	.74214	.76304	.79577	.82708	.84928	.88207		
		.95	.60010	.69549	.72955	.75911	.78548	.80232	.83826		
16b	0.88222	2	.80	.66560	.77722	.79675	.83156	.85381	.88935	.91737	
		.90	.63208	.74214	.76304	.79577	.82032	.84928	.88207		
		.95	.60165	.69549	.72955	.75911	.78548	.80232	.83826		
16c	0.88222	4	.80	.69530	.76147	.79629	.83156	.85381	.88935	.91428	
		.90	.66153	.72767	.76252	.79577	.82032	.84928	.88134		
		.95	.63046	.69498	.72897	.75911	.78548	.79841	.82273		

Table D-2. Additional Simulation Output (continued)

Case	KK	TT	TM	RS	CL	\hat{R}^{*o}	D	Mean	S.D.
17a	25	12.5	8.36	0.8822	80.0	0.8816	-0.0006	0.8493	0.0341
					90.0	0.8716	-0.0107	0.8291	0.0346
					95.0	0.8614	-0.0208	0.8098	0.0343
17b	25	12.5	8.36	0.8822	80.0	0.8728	-0.0095	0.8479	0.0338
					90.0	0.8716	-0.0107	0.8277	0.0344
					95.0	0.8650	-0.0172	0.8084	0.0341
17c	25	12.5	8.36	0.8822	80.0	0.8816	-0.0006	0.8508	0.0334
					90.0	0.8735	-0.0087	0.8308	0.0340
					95.0	0.8614	-0.0208	0.8113	0.0336

Table D-1. Simulation Results (continued).

Case	RS	Null Runs	CL	Minimum	Lower Confidence Limit 10 %	Median 25 %	Estimate 75 %	Percentile 90 %	Values Maximum
17a	0.88222	0	80	72335	80692	82532	85305	87263	89156 94305
			:90	:70154	:78597	:80472	:83297	:85304	:87156 :92156
			:95	:68198	:76556	:78540	:81378	:83397	:85146 :89572
17c	0.88222	0	80	72300	80702	82511	84394	87263	89156 93270
			:90	:70116	:78608	:80448	:82371	:85304	:87156 :91237
			:95	:68159	:76668	:78514	:80451	:83397	:85146 :88947
17c	0.88222	0	80	73138	80702	82532	85328	87263	89261 93270
			:90	:70962	:78609	:80472	:83323	:85304	:87353 :91237
			:95	:69006	:76668	:78540	:81406	:83397	:85448 :88947

Table D-2. Additional Simulation Output (continued)

Case	KK	TT	TM	RS	CL	\hat{R}^{*o}	D	Mean	S.D.
18a	25	0.62	0.42	0.9753	80.0	0.8359	-0.1394	0.8305	0.0195
					90.0	0.7402	-0.2351	0.6993	0.0277
					95.0	0.6437	-0.3316	0.5104	0.0836
18b	25	0.62	0.42	0.9753	80.0	0.8359	-0.1394	0.8306	0.0200
					90.0	0.7402	-0.2351	0.6972	0.0263
					95.0	0.6437	-0.3316	0.5044	0.0804
18c	25	0.62	0.42	0.9753	80.0	0.8359	-0.1394	0.8304	0.0198
					90.0	0.7402	-0.2351	0.6981	0.0267
					95.0	0.6437	-0.3316	0.5073	0.0817

Table D-1. Simulation Results (continued).

Case	RS	Null Runs	CL	Lower 10 %	Confidence Limit 25 %	Median	Estimate 75 %	Percentile 90 %	Values Maximum
18a	0.97530	1184	.80	.72345	.82358	.83590	.83590	.83590	.84003
		:90	:66288	:68406	:68406	:68406	:72127	:74017	:77600
		:95	:45815	:45815	:45815	:45815	:63745	:63745	:70008
18b	0.97530	1164	.80	.72802	.82358	.83590	.83590	.83590	.84003
		:90	:67179	:68406	:68406	:68406	:69292	:74017	:77600
		:95	:45815	:45815	:45815	:45815	:62593	:63745	:70008
18c	0.97530	1251	.80	.75679	.82358	.83590	.83590	.83590	.84003
		:90	:68406	:68406	:68406	:68406	:72127	:74017	:77600
		:95	:45815	:45815	:45815	:45815	:63745	:63745	:70008

Table D-2. Additional Simulation Output (continued)

Case	KK	TT	TM	RS	CL	\hat{R}^*o	D	Mean	S.D.
19a	25	1.25	0.84	0.9753	80.0	0.9143	-0.0610	0.9069	0.0156
					90.0	0.8603	-0.1150	0.8409	0.0194
					95.0	0.8023	-0.1730	0.7372	0.0622
19b	25	1.25	0.84	0.9753	80.0	0.9143	-0.0610	0.9067	0.0163
					90.0	0.8603	-0.1150	0.8402	0.0193
					95.0	0.8023	-0.1730	0.7352	0.0618
19c	25	1.25	0.84	0.9753	80.0	0.9143	-0.0610	0.9064	0.0167
					90.0	0.8603	-0.1150	0.8396	0.0191
					95.0	0.8023	-0.1730	0.7342	0.0615

Table D-1. Simulation Results (continued).

Case	RS	Null Runs	CL	Lower Confidence Limit 10 %	Median 25 %	Estimate 75 %	Percentile 90 %	Values Maximum
19a	0.97530	427	.80	.83156	.88935	.90751	.91428	.91428
			.90	.79577	.82708	.82708	.86033	.86033
			.95	.67687	.67687	.67687	.79841	.80232
19b	0.97530	424	.80	.81518	.88935	.90751	.91428	.91428
			.90	.78157	.82708	.82708	.86033	.86033
			.95	.67687	.67687	.67687	.79841	.80232
19c	0.97530	438	.80	.81299	.88935	.90751	.91428	.91428
			.90	.77752	.82708	.82708	.86033	.86033
			.95	.67687	.67687	.67687	.79841	.80232

Table D-2. Additional Simulation Output (continued)

Case	KK	TT	TM	RS	CL	$\hat{R}^{\ast o}$	D	Mean	S.D.
20a	25	2.50	1.67	0.9753	80.0	0.9562	-0.0191	0.9439	0.0181
					90.0	0.9275	-0.0478	0.9168	0.0102
					95.0	0.8971	-0.0782	0.8770	0.0322
20b	25	2.50	1.67	0.9753	80.0	0.9562	-0.0191	0.9438	0.0182
					90.0	0.9275	-0.0478	0.9165	0.0098
					95.0	0.8971	-0.0782	0.8764	0.0324
20c	25	2.50	1.67	0.9753	80.0	0.9562	-0.0191	0.9436	0.0184
					90.0	0.9275	-0.0478	0.9164	0.0099
					95.0	0.8971	-0.0782	0.8763	0.0321

Table D-1. Simulation Results (continued).

Case	RS	Null Runs	CL	Minimum	10 %	Confidence Limit	Median	Percentile 75 %	Percentile 90 %	Values Maximum
20a	0.97530	89	.80	.88240	.92226	.93511	.94636	.95263	.95618	.95800
		.90	.86306	.90232	.90944	.92156	.92754	.92754	.92754	.93949
		.95	.82272	.82272	.87538	.89354	.89572	.89572	.89572	.91598
20b	0.97530	96	.80	.88265	.92402	.93270	.94636	.95263	.95618	.95800
		.90	.86334	.90572	.90944	.91705	.92754	.92754	.92754	.93949
		.95	.82272	.82272	.87127	.89354	.89572	.89572	.89572	.91598
20c	0.97530	102	.80	.88265	.92373	.93511	.94636	.95263	.95618	.95800
		.90	.86334	.90563	.90944	.91705	.92754	.92754	.92754	.93949
		.95	.82272	.82272	.87127	.89354	.89572	.89572	.89572	.91598

Table D-2. Additional Simulation Output (continued)

Case	KK	TT	TM	RS	CL	\hat{R}^{*o}	D	Mean	S.D.
21a	25	5.00	3.34	0.9753	80.0	0.9711	-0.0042	0.9603	0.0158
					90.0	0.9631	-0.0122	0.9493	0.0137
					95.0	0.9472	-0.0281	0.9363	0.0126
21b	25	5.00	3.34	0.9753	80.0	0.9711	-0.0042	0.9607	0.0157
					90.0	0.9600	-0.0153	0.9496	0.0136
					95.0	0.9472	-0.0281	0.9362	0.0128
21c	25	5.00	3.34	0.9753	80.0	0.9711	-0.0122	0.9492	0.0141
					90.0	0.9631	-0.0122	0.9492	0.0141
					95.0	0.9472	-0.0281	0.9360	0.0125

Table D-1. Simulation Results (continued).

Case	RS	Null Runs	CL	Minimum	10 %	Confidence Limit	Estimate	Percentile 75 %	Percentile 90 %	Values Maximum
21a	0.97530	8	.80	.91857	.94488	.95494	.96034	.97111	.97603	.97883
			.90	.90748	.93475	.94449	.94990	.95768	.96309	.96935
			.95	.89683	.91889	.93019	.93849	.94527	.94643	.95717
21b	0.97530	5	.80	.91860	.94488	.95494	.96138	.97111	.97603	.97883
			.90	.90752	.93475	.94449	.95183	.95768	.95998	.96935
			.95	.89687	.91889	.93019	.93849	.94527	.94643	.95717
21c	0.97530	3	.80	.91349	.94485	.95030	.96034	.97111	.97603	.97883
			.90	.90223	.93471	.94037	.94990	.95768	.96309	.96935
			.95	.89149	.91889	.93019	.93849	.94527	.94643	.95717

Table D-2. Additional Simulation Output (continued)

Case	KK	TT	TM	RS	CL	\hat{R}^{*o}	D	Mean	S.D.
22a	60	2.70	1.62	0.8731	80.0	0.8262	-0.0469	0.7790	0.0679
					90.0	0.7512	-0.1219	0.6943	0.0634
					95.0	0.6521	-0.2209	0.5911	0.0660
22b	60	2.70	1.62	0.8731	80.0	0.8288	-0.0443	0.7811	0.0680
					90.0	0.7525	-0.1206	0.6953	0.0625
					95.0	0.6530	-0.2201	0.5899	0.0642
22c	60	2.70	1.62	0.8731	80.0	0.8246	-0.0484	0.7761	0.0676
					90.0	0.7478	-0.1253	0.6909	0.0616
					95.0	0.6495	-0.2236	0.5873	0.0636

Table D-1. Simulation Results (continued).

Case	RS	Null Runs	CL	Minimum	10 %	Confidence Limit	Estimate	Percentile 75 %	90 %	Values	Maximum
22a	0.87306	0	.80	.52180	.69050	.73853	.78167	.81674	.85286	.99093	
			.90	.46500	.62229	.66195	.69235	.72130	.75116	.98088	
			.95	.37713	.52792	.56676	.59199	.61670	.63962	.96110	
22b	0.87306	0	.80	.55336	.69440	.73977	.78298	.82177	.85451	.99474	
			.90	.49445	.62650	.66268	.69292	.72486	.75247	.98890	
			.95	.37971	.52699	.56710	.59095	.61793	.63880	.97731	
22c	0.87306	0	.80	.52401	.69267	.73345	.78012	.81573	.84941	.99585	
			.90	.46732	.62483	.65758	.69134	.72028	.74775	.99124	
			.95	.37810	.52751	.56343	.58907	.61514	.63736	.98207	

Table D-2. Additional Simulation Output (continued)

Case	KK	TT	TM	RS	CL	\hat{R}^{*o}	D	Mean	S.D.
23a	60	3.37	2.02	0.8731	80.0	0.8410	-0.0321	0.7942	0.0570
					90.0	0.7785	-0.0945	0.7255	0.0499
					95.0	0.7003	-0.1728	0.6442	0.0464
23b	60	3.37	2.02	0.8731	80.0	0.8419	-0.0312	0.7949	0.0616
					90.0	0.7825	-0.0906	0.7270	0.0560
					95.0	0.7029	-0.1701	0.6467	0.0514
23c	60	3.37	2.02	0.8731	80.0	0.8391	-0.0340	0.7926	0.0593
					90.0	0.7767	-0.0964	0.7242	0.0523
					95.0	0.7001	-0.1729	0.6434	0.0471

Table D-1. Simulation Results (continued).

Case	RS	Null Runs	CL	Minimum	10 %	Confidence Limit	Estimate	Percentile 75 %	90 %	Maximum
23a	0.87306	0	.80	.59988	.72351	.75778	.79763	.83538	.85795	.97649
			.90	.54795	.66462	.69580	.72965	.75616	.77854	.95084
			.95	.45881	.59143	.62638	.65049	.67132	.69025	.90157
23b	0.87306	0	.80	.59403	.72129	.75771	.79692	.83623	.86128	.98131
			.90	.54167	.66402	.69603	.73001	.75780	.78248	.96081
			.95	.46142	.59407	.62577	.65024	.67127	.69244	.92110
23c	0.87306	0	.80	.62630	.71817	.75536	.79716	.83404	.85771	.96837
			.90	.57296	.66041	.69307	.73122	.75588	.77669	.93418
			.95	.46050	.58928	.62165	.64834	.67042	.68987	.86939

Table D-2. Additional Simulation Output (continued)

Case	KK	TT	TM	RS	CL	\hat{R}^{*o}	D	Mean	S.D.
24a	60	6.75	4.04	0.8731	80.0	0.8640	-0.0091	0.8260	0.0442
					90.0	0.8445	-0.0286	0.7910	0.0433
					95.0	0.8118	-0.0613	0.7548	0.0402
24b	60	6.75	4.04	0.8731	80.0	0.8619	-0.0112	0.8239	0.0437
					90.0	0.8425	-0.0305	0.7890	0.0429
					95.0	0.8122	-0.0608	0.7531	0.0402
24c	60	6.75	4.04	0.8731	80.0	0.8573	-0.0158	0.8194	0.0445
					90.0	0.8408	-0.0323	0.7846	0.0439
					95.0	0.8090	-0.0641	0.7491	0.0413

Table D-1. Simulation Results (continued).

Case	RS	Null Runs	CL	Minimum	10 %	Confidence Limit	Median	Percentile 75 %	Percentile 90 %	Values Maximum
24a	0.87306	0	.80	.66551	.77050	.79687	.822778	.85871	.88109	.93288
			.90	.63138	.73626	.76276	.79314	.82338	.84450	.88911
			.95	.60036	.70318	.72856	.75803	.78587	.80365	.89870
24b	0.87306	0	.80	.64083	.76983	.79571	.82485	.85311	.87970	.93627
			.90	.60736	.73544	.76107	.79011	.81862	.84252	.89290
			.95	.57719	.70207	.72747	.75513	.78299	.80259	.84319
24c	0.87306	0	.80	.66632	.76170	.79211	.82243	.84971	.87603	.93976
			.90	.63226	.72751	.75776	.78764	.81534	.84081	.89862
			.95	.60128	.69529	.72426	.75260	.77863	.80057	.83745

Table D-2. Additional Simulation Output (continued)

Case	KK	TT	TM	RS	CL	\hat{R}^{*o}	D	Mean	S.D.
25a	60	13.5	8.09	0.8731	80.0	0.8679	-0.0052	0.8411	0.0324
					90.0	0.8609	-0.0122	0.8206	0.0328
					95.0	0.8519	-0.0212	0.8011	0.0328
25b	60	13.5	8.09	0.8731	80.0	0.8693	-0.0037	0.8426	0.0317
					90.0	0.8622	-0.0109	0.8221	0.0322
					95.0	0.8524	-0.0206	0.8026	0.0321
25c	60	13.5	8.09	0.8731	80.0	0.8678	-0.0053	0.8411	0.0331
					90.0	0.8616	-0.0115	0.8206	0.0335
					95.0	0.8529	-0.0202	0.8011	0.0333

Table D-1. Simulation Results (continued).

Case	RS	Null Runs	CL	Minimum	10 %	25 %	Median	75 %	90 %	Maximum	Values
25a	0.87306	0	.80	73071	79953	82120	84188	86174	88054	92451	
			.90	70890	77826	80022	82141	84177	86092	90512	
			.95	68930	75857	78082	80200	82235	84155	88415	
25b	0.87306	0	.80	71861	80235	82333	84342	86329	88198	92267	
			.90	69672	78122	80252	82297	84318	86215	90405	
			.95	67713	76145	78301	80349	82390	84271	88429	
25c	0.87306	0	.80	73682	79911	81992	84246	86295	88116	92694	
			.90	71493	77780	79914	82207	84275	86162	90814	
			.95	69522	75818	77971	80271	82339	84207	88779	

Table D-2. Additional Simulation Output (continued)

Case	KK	TT	TM	RS	CL	$\hat{R}^{\ast}o$	D	Mean	S.D.
26a	60	3.58	2.14	0.8329	80.0	0.7999	-0.0330	0.7462	0.0671
					90.0	0.7262	-0.1067	0.6670	0.0580
					95.0	0.6341	-0.1988	0.5770	0.0510
26b	60	3.58	2.14	0.8329	80.0	0.8013	-0.0317	0.7480	0.0657
					90.0	0.7259	-0.1070	0.6687	0.0579
					95.0	0.6388	-0.1941	0.5786	0.0542
26c	60	3.58	2.14	0.8329	80.0	0.8016	-0.0313	0.7479	0.0683
					90.0	0.7291	-0.1038	0.6689	0.0606
					95.0	0.6389	-0.1941	0.5790	0.0550

Table D-1. Simulation Results (continued).

Case	RS	Null Runs	CL	Minimum	Lower Confidence Limit	Median	Percentile 75%	Percentile 90%	Values Maximum	
26a	0.83293	0	80	50494	65423	70476	75277	79207	82132	99003
			90	44907	58884	63339	67574	70396	72624	97899
			95	38278	51215	55374	58451	60620	62661	.95730
26b	0.83293	0	80	44914	66803	70691	75246	79448	81974	99182
			90	39837	60232	63512	67374	70225	72594	98276
			95	35423	52336	55745	58320	60475	62804	.96488
26c	0.83293	0	80	49078	65833	70811	75293	79397	82203	99675
			90	43589	59225	63602	67552	70268	72909	99313
			95	38318	52008	55696	58450	60797	62949	.98594

Table D-2. Additional Simulation Output (continued)

Case	KK	TT	TM	RS	CL	\hat{R}^{*o}	D	Mean	S.D.
27a	60	4.47	2.68	0.8329	80.0	0.8104	-0.0226	0.7572	0.0615
					90.0	0.7577	-0.0752	0.6938	0.0546
					95.0	0.6870	-0.1459	0.6246	0.0459
27b	60	4.47	2.68	0.8329	80.0	0.8106	-0.0223	0.7589	0.0606
					90.0	0.7543	-0.0786	0.6954	0.0535
					95.0	0.6848	-0.1482	0.6257	0.0452
27c	60	4.47	2.68	0.8329	80.0	0.8126	-0.0203	0.7591	0.0624
					90.0	0.7601	-0.0729	0.6962	0.0565
					95.0	0.6901	-0.1428	0.6278	0.0478

Table D-1. Simulation Results (continued).

Case	RS	Null Runs	CL	Minimum	Lower Confidence Limit	Median	Percentile 75 %	Percentile 90 %	Values Maximum
27a	0.83293	0	.80	.50452	.67785	.71738	.75978	.79907	.83384 .94963
			.90	.45751	.62261	.65951	.69857	.73381	.75769 .89629
			.95	.41601	.56529	.59974	.63164	.65610	.67397 .79846
27b	0.83293	0	.80	.51810	.67842	.72067	.76371	.79991	.83328 .94105
			.90	.46947	.62258	.66315	.70358	.73528	.75428 .87922
			.95	.42629	.56412	.60144	.63689	.65631	.67342 .76751
27c	0.83293	0	.80	.54827	.67671	.72177	.76238	.80267	.83756 .97651
			.90	.49872	.61950	.66378	.70030	.73596	.76007 .95089
			.95	.45421	.56337	.60268	.63476	.65904	.67770 .90167

Table D-2. Additional Simulation Output (continued)

Case	KK	TT	TM	RS	CL	\hat{R}^{o}	D	Mean	S.D.
28a	60	8.94	5.36	0.8329	80.0	0.8221	-0.0108	0.7846	0.0459
					90.0	0.8066	-0.0263	0.7502	0.0456
					95.0	0.7856	-0.0473	0.7165	0.0439
28b	60	8.94	5.36	0.8329	80.0	0.8249	-0.0080	0.7854	0.0478
					90.0	0.8092	-0.0237	0.7510	0.0477
					95.0	0.7911	-0.0419	0.7172	0.0459
28c	60	8.94	5.36	0.8329	80.0	0.8251	-0.0078	0.7832	0.0473
					90.0	0.8080	-0.0249	0.7487	0.0470
					95.0	0.7845	-0.0484	0.7150	0.0453

Table D-1. Simulation Results (continued).

Case	RS	Null Runs	CL	Minimum	Lower Confidence Limit	Estimate	Percentile 75 %	Percentile 90 %	Values Maximum
28a	0.83293	0	:80	:63064	:72377	:75268	:78790	:81578	:84218 :94019
		:90	:59758	:68954	:71818	:75363	:78143	:80659	:89934
		:95	:56788	:65760	:68544	:72030	:74695	:77134	:83842
28b	0.83293	0	:80	:62536	:71988	:75456	:78770	:81720	:84323 :91227
		:90	:59199	:68591	:71996	:75361	:78241	:80921	:87495
		:95	:56204	:65447	:68714	:72032	:74817	:77337	:82952
28c	0.83293	0	:80	:62536	:72284	:75191	:78245	:81647	:84227 :91056
		:90	:59200	:68852	:71714	:74805	:78204	:80799	:87266
		:95	:56205	:65650	:68452	:71466	:74790	:77207	:82558

Table D-2. Additional Simulation Output (continued)

Case	KK	TT	TM	RS	CL	$\hat{R}^{\ast o}$	D	Mean	S.D.
29a	60	17.9	10.7	0.8329	80.0	0.8269	-0.0060	0.8002	0.0326
					90.0	0.8198	-0.0131	0.7791	0.0329
					95.0	0.8111	-0.0219	0.7595	0.0329
29b	60	17.9	10.7	0.8329	80.0	0.8288	-0.0041	0.8002	0.0339
					90.0	0.8230	-0.0099	0.7791	0.0324
					95.0	0.8137	-0.0192	0.7595	0.0343
29c	60	17.9	10.7	0.8329	80.0	0.8299	-0.0030	0.8016	0.0344
					90.0	0.8227	-0.0103	0.7805	0.0348
					95.0	0.8156	-0.0173	0.7609	0.0348

Table D-1. Simulation Results (continued).

Case	RS	Null Runs	CL	Minimum	Lower Confidence Limit	Estimate	Percentile 75 %	90 %	Values Maximum
29a	0.83293	0	:80	:67933	:75979	:78117	:80152	:82098	:84042 :90200
			:90	:65728	:73825	:75985	:78054	:80016	:81979 :88303
			:95	:63776	:71851	:74026	:76102	:78049	:80022 :86379
29b	0.83293	0	-80	:67260	:75726	:77803	:80023	:82430	:84348 :88634
			:90	:65057	:73553	:75649	:77902	:80359	:82301 :86695
			:95	:63112	:71581	:73675	:75938	:78410	:80374 :84770
29c	0.83293	0	:80	:70176	:75812	:77888	:80255	:82497	:84331 :89342
			:90	:67973	:73646	:75741	:78138	:80425	:82268 :87374
			:95	:66021	:71679	:73774	:76162	:78484	:80304 :85396

Table D-2. Additional Simulation Output (continued)

Case	KK	TT	TM	RS	CL	\hat{R}^*	D	Mean	S.D.
30a	25	0.62	0.42	0.9753	80.0	0.9377	-0.0376	0.8894	0.0554
					90.0	0.9120	-0.0633	0.8156	0.1078
					95.0	0.8871	-0.0882	0.7159	0.1969
30b	25	0.62	0.42	0.9753	80.0	0.9377	-0.0376	0.8895	0.0554
					90.0	0.9120	-0.0633	0.8152	0.1083
					95.0	0.8871	-0.0882	0.7144	0.1983
30c	25	0.62	0.42	0.9753	80.0	0.9377	-0.0376	0.8917	0.0551
					90.0	0.9120	-0.0633	0.8203	0.1071
					95.0	0.8871	-0.0882	0.7243	0.1954

Table D-1. Simulation Results (continued).

Case	RS	Null Runs	CL	Minimum	10 %	25 %	Median	Estimate	Percentile 75 %	90 %	Values Maximum
30a	0.97530	549	.80	.72345	.82358	.83590	.93765	.93765	.93765	.93765	
			.90	.66288	.68406	.68406	.91201	.91201	.91201	.91201	
			.95	.45815	.45815	.45815	.88707	.88707	.88707	.88707	
30b	0.97530	550	.80	.75679	.82358	.83590	.93765	.93765	.93765	.93765	
			.90	.68406	.68406	.68406	.91201	.91201	.91201	.91201	
			.95	.45815	.45815	.45815	.88707	.88707	.88707	.88707	
30c	0.97530	571	.80	.75679	.82358	.83590	.93765	.93765	.93765	.93765	
			.90	.68406	.68406	.68406	.91201	.91201	.91201	.91201	
			.95	.45815	.45815	.45815	.88707	.88707	.88707	.88707	

Table D-2. Additional Simulation Output (continued)

Case	KK	TT	TM	RS	CL	\hat{R}^{*o}	D	Mean	S.D.
31a	25	1.25	0.84	0.9753	80.0	0.9683	-0.0070	0.9257	0.0313
					90.0	0.9550	-0.0203	0.8764	0.0554
					95.0	0.9418	-0.0335	0.8018	0.1076
31b	25	1.25	0.84	0.9753	80.0	0.9683	-0.0070	0.9247	0.0306
					90.0	0.9550	-0.0203	0.8732	0.0548
					95.0	0.9418	-0.0335	0.7943	0.1076
31c	25	1.25	0.84	0.9753	80.0	0.9683	-0.0070	0.9256	0.0317
					90.0	0.9550	-0.0203	0.8753	0.0560
					95.0	0.9418	-0.0335	0.7984	0.1091

Table D-1. Simulation Results (continued).

Case	RS	Null Runs	CL	Minimum	10 %	Lower Confidence Limit	Median	75 %	90 %	Maximum	Values
31a	0.97530	311	:80	:83156	:88935	:90751	:91428	:96832	:96832	:96832	
			:90	:79577	:82708	:82708	:86033	:95499	:95499	:95499	
			:95	:67687	:67687	:67687	:79841	:94184	:94184	:94184	
31b	0.97530	288	:80	:81518	:88935	:90751	:91428	:96832	:96832	:96832	
			:90	:78157	:82708	:82708	:86033	:95499	:95499	:95499	
			:95	:67687	:67687	:67687	:79841	:94184	:94184	:94184	
31c	0.97530	309	:80	:81299	:88935	:90751	:91428	:96832	:96832	:96832	
			:90	:77752	:82708	:82708	:86033	:95499	:95499	:95499	
			:95	:67687	:67687	:67687	:79841	:94184	:94184	:94184	

Table D-2. Additional Simulation Output (continued)

Case	KK	TR	TM	RS	CL	\hat{R}^{*o}	D	Mean	S.D.
32a	25	2.50	1.67	0.9753	80.0	0.9562	-0.0191	0.9470	0.0209
					90.0	0.9283	-0.0470	0.9214	0.0195
					95.0	0.9705	-0.0048	0.8841	0.0398
32b	25	2.50	1.67	0.9753	80.0	0.9562	-0.0191	0.9473	0.0211
					90.0	0.9283	-0.0470	0.9218	0.0199
					95.0	0.9705	-0.0048	0.8847	0.0405
32c	25	2.50	1.67	0.9753	80.0	0.9562	-0.0191	0.9472	0.0217
					90.0	0.9395	-0.0358	0.9220	0.0208
					95.0	0.9705	-0.0048	0.8854	0.0408

Table D-1. Simulation Results (continued).

Case	RS	Null Runs	CL	Minimum	Lower Confidence Limit	Median	Estimate	Percentile 75 %	Percentile 90 %	Values Maximum
32a	0.97530	79	.80	.88240	.92417	.94305	.95263	.95618	.95618	.98403
			.90	.86306	.90590	.90944	.92156	.92754	.92832	.97724
			.95	.82272	.82272	.87577	.89354	.89572	.90735	.97049
32b	0.97530	86	.80	.88265	.92417	.93511	.95263	.95618	.95618	.98403
			.90	.86334	.90590	.90944	.92156	.92754	.92832	.97724
			.95	.82272	.82272	.88077	.89354	.89572	.90735	.97049
32c	0.97530	94	.80	.88265	.92402	.93511	.95263	.95618	.95800	.98403
			.90	.86334	.90572	.90944	.92156	.92754	.93949	.97724
			.95	.82272	.82272	.87577	.89354	.89572	.91598	.97049

Table D-2. Additional Simulation Output (continued)

Case	KK	TT	TM	RS	CL	\hat{R}^{*o}	D	Mean	S.D.
33a	25	5.00	3.34	0.9753	80.0	0.9711	-0.0042	0.9605	0.0160
					90.0	0.9631	-0.0122	0.9496	0.0140
					95.0	0.9472	-0.0281	0.9366	0.0133
33b	25	5.00	3.34	0.9753	80.0	0.9711	-0.0042	0.9609	0.0158
					90.0	0.9631	-0.0122	0.9498	0.0138
					95.0	0.9472	-0.0281	0.9365	0.0132
33c	25	5.00	3.34	0.9753	80.0	0.9711	-0.0042	0.9604	0.0160
					90.0	0.9631	-0.0122	0.9494	0.0142
					95.0	0.9472	-0.0281	0.9362	0.0128

Table D-1. Simulation Results (concluded).

Case	RS	Null Runs	CL	Minimum 10 %	Lower Confidence Limit 25 %	Median	Estimate 75 %	Percentile 90 %	Values Maximum
33a	0.97530	8	80	:91857	:94488	:95494	:96034	:97111	:97603 :99199
			:90	:90748	:93475	:94449	:94990	:95768	:96309 :98855
			:95	:89683	:91889	:93019	:93849	:94527	:94643 :98513
33b	0.97530	5	:80	:91860	:94488	:95494	:96138	:97111	:97603 :99199
			:90	:90752	:93475	:94449	:95183	:95768	:96309 :98855
			:95	:89687	:91889	:93019	:93849	:94527	:94643 :98513
33c	0.97530	3	:80	:91349	:94485	:95030	:96034	:97111	:97603 :99199
			:90	:90223	:93471	:94037	:94990	:95768	:96309 :98855
			:95	:89149	:91889	:93019	:93849	:94527	:94643 :98513

Table D-2. Additional simulation output (concluded)

APPENDIX E

REGRESSION OF OBSERVED ACCURACY

Examination of the tabulated data in Appendix D suggests that a linear relationship is not directly applicable to regression of the accuracy measure, d , on any of the other variables. The terms TT, developed in section IV.B.2, and KK, the number of components, appear to be the most likely candidate independent variables for the model. Plots of these terms versus D suggest that an exponential decreasing or inverse power curve could be used to model procedure accuracy on TT, i.e.

$$D = a \cdot \exp(b \cdot TT) \quad (E.1)$$

$$D = a \cdot TT^b \quad (E.2)$$

where a and b are appropriate constants from the underlying response function. Each of these models can be easily transformed into a linear model by taking the natural logarithm and redefining variables and coefficients where convenient.

The plots indicate, however, that the system configuration has a strong effect. Therefore, curve fitting will be initially confined to similar configurations in the following groups: Cases 01 to 12, Cases 14 to 17, and Cases 22 to 29. Cases 18 to 21 will be considered only with reservations due to the artificial bias introduced by the particular procedure used which ignored failureless runs.

Cases 30 to 33 will not be fitted since the procedure employed caused the sample to be drawn from two quite unlike distributions and the plots demonstrated an apparent discontinuity between the results of the two methods (see Section II.C and Appendix C). Finally, if the group fits are good, a composite fit will be attempted for Cases 01 to 17 and 22 to 29. This fit would not be expected to be good due to the observed inter-group plot variation.

A. EXPONENTIAL CURVE FIT

Consider the linearized exponential model

$$D' = A + b \cdot TT \quad (E.3)$$

where $D' = \ln(-D)$ and $A = \ln(-a)$. From the Method of Least Squares, expressions for A and b can be derived directly.

$$b = \frac{\frac{1}{n} \sum_{i=1}^n TT_i D'_i - \frac{1}{n} \left[\sum_{i=1}^n TT_i \right] \left[\sum_{i=1}^n D'_i \right]}{\sum_{i=1}^n TT_i^2 - \frac{1}{n} \left[\sum_{i=1}^n TT_i \right]^2}$$

$$A = \frac{1}{n} \left[\sum_{i=1}^n D'_i \right] - \frac{b}{n} \left[\sum_{i=1}^n TT_i \right]$$

and the coefficient of determination [Ref. 6] is

$$r^2 = \frac{\left[\frac{1}{n} \sum_{i=1}^n TT_i D'_i - \frac{1}{n} \left[\sum_{i=1}^n D'_i \right] \left[\sum_{i=1}^n TT_i \right] \right]^2}{\left[\sum_{i=1}^n TT_i^2 - \frac{1}{n} \left[\sum_{i=1}^n TT_i \right]^2 \right] \left[\sum_{i=1}^n D'^2_i - \frac{1}{n} \left[\sum_{i=1}^n D'_i \right]^2 \right]}$$

The results of the exponential curve fit were as follows:

<u>Cases</u>	<u>α</u>	<u>a</u>	<u>b</u>	<u>R^2</u>
01-12	.20	-0.040	-0.065	0.690
	:10	-0.094	-0.076	0.724
	.05	-0.073	-0.048	0.738
14-17	.20	-0.118	-0.290	0.942
	:10	-0.301	-0.282	0.938
	.05	-0.480	-0.260	0.988
22-29	.20	-0.049	-0.156	0.896
	:10	-0.153	-0.170	0.899
	.05	-0.346	-0.216	0.917

B. INVERSE POWER CURVE FIT

The power curve may be linearized to the form

$$D' = A + b \cdot TT' \quad (E.3)$$

where A and D' are defined as before and $TT' = \ln(TT)$. The coefficients, A and b , and the coefficient of determination may be found as described in the preceding section with the substitution of TT' for TT where occurring.

The results of the power curve fit were as follows:

<u>Cases</u>	<u>α</u>	<u>a</u>	<u>b</u>	<u>R^2</u>
01-12	.20	-0.130	-0.868	0.844
	:10	-0.368	-1.016	0.883
	.05	-0.780	-1.124	0.893
14-17	.20	-0.664	-2.085	0.986
	:10	-1.589	-2.016	0.972
	.05	-2.110	-1.828	0.992
22-29	.20	-0.159	-1.305	0.989
	:10	-0.543	-1.412	0.977
	.05	-1.041	-1.430	0.980
01-17	.20	-0.136	-1.060	0.648
22-29	:10	-0.459	-1.228	0.793
	.05	-0.936	-1.303	0.845

Comparing these results with those of the exponential curve fit indicates that the power curve provides a better fit for the observed simulation data. However, the variation in the coefficients between different system

configurations implies that, while the fit may be good within like groups, the fit is much more approximate across the groups. This is borne out by the composite fit listed last in the preceding table.

C. REGRESSION OF D ON TT AND KK

For this regression the model chosen was a combined power curve

$$D = a \cdot TT^b \cdot KK^c \quad (E.5)$$

which linearizes to

$$D' = A + b \cdot TT' + c \cdot KK' \quad (E.6)$$

where D' , A , and TT' are defined as before and $KK' = \ln(KK)$.

Solving for the coefficient values by the Method of Least Squares yields the following:

$$c = \frac{\left[\frac{S_1 \cdot S_2}{n} - S_6 \right] \left[\frac{S_1 \cdot S_3}{n} - S_8 \right] - \left[\frac{S_2 \cdot S_3}{n} - S_7 \right] \left[\frac{S_1^2}{n} - S_4 \right]}{\left[\frac{S_1^2}{n} - S_4 \right] \left[\frac{S_3^2}{n} - S_5 \right] - \left[\frac{S_1 \cdot S_3}{n} - S_8 \right]^2}$$

$$b = \frac{\left[\frac{S_1 \cdot S_2}{n} - S_6 \right] - c \left[\frac{S_1 \cdot S_3}{n} - S_8 \right]}{\frac{S_1^2}{n} - S_4}$$

$$a = \exp \left[\frac{1}{n} S_2 - \frac{b}{n} S_1 - \frac{c}{n} S_3 \right]$$

where

$$S_1 = \sum_{i=1}^n TT'_i \quad S_2 = \sum_{i=1}^n D'_i \quad S_3 = \sum_{i=1}^n KK'_i$$

$$S_4 = \sum_{i=1}^n TT'^2_i \quad S_5 = \sum_{i=1}^n KK'^2_i \quad S_6 = \sum_{i=1}^n [TT'_i \cdot D'_i]$$

$$S7 = \sum_{i=1}^n [D'_i \cdot KK'_i] \quad \text{and} \quad S8 = \sum_{i=1}^n [TT'_i \cdot KK'_i]$$

From the data for cases 01 through 17 and 22 through 29, the following values for a , b , and c were obtained:

$\alpha = 0.20$	$a = -0.080$	$b = -1.028$	$c = 0.129$
$\alpha = 0.10$	$a = -0.386$	$b = -1.200$	$c = 0.033$
$\alpha = 0.05$	$a = -1.038$	$b = -1.279$	$c = -0.043$

An approximate coefficient of determination was calculated by defining

$$TM = TT \cdot KK^{c/b}$$

so that

$$D = a \cdot TM^b$$

which is the inverse power curve model and the two variable procedure of Section B can be used. This yielded an r^2 value of 0.626 for $\alpha = 0.2$, which shows no improvement of fit for the three variable approach.

Appendix D lists TM values for $\alpha = 0.2$ for information.

D. REGRESSION OF STANDARD DEVIATION

Examination of the sample standard deviation values listed in Appendix D also suggests that the power curve form would be appropriate to model the standard deviation on TT.

$$S.D. = a \cdot TT^b$$

Proceeding as in Section B, the following values are obtained:

$\alpha = 0.20$	$a = 0.094$	$b = -0.300$	$r^2 = 0.523$
$\alpha = 0.10$	$a = 0.075$	$b = -0.219$	$r^2 = 0.374$
$\alpha = 0.05$	$a = 0.072$	$b = -0.215$	$r^2 = 0.408$

which indicates a poor fit at best.

However, the data suggests that the sample standard deviation may be better predicted as a function of the number of component tests, i.e.

$$S.D. = a \cdot N^b$$

where N represents the "equivalent" number of system tests as derived in Section IV.B.2 for use in Equation (4.3).

The regression yields the following values:

$\alpha = 0.20$	$a = 0.213$	$b = -0.391$	$r^2 = 0.853$
$\alpha = 0.10$	$a = 0.186$	$b = -0.365$	$r^2 = 0.825$
$\alpha = 0.05$	$a = 0.164$	$b = -0.339$	$r^2 = 0.799$

This fit is better and implies that the primary mechanism to reduce the sample standard deviation is to increase the number of component tests. As the data base is limited, little more than that may be averred at this level of analysis.

APPENDIX F

COMPUTER PROGRAM

The following pages contain a representative listing of the main computer program utilized in the simulation. Three proprietary routines were used for binomial random variate generation (GGBIN), inverse Chi-Square value determination (MDCHI), and ordering of the estimate arrays (VSORTA). Reference 4 provides information concerning the contents and use of these routines. Equivalent routines could be used without penalty to either accuracy or consistence of the simulation results.

The program was written in the FORTRAN IV language for use on the IBM-360 computer system installed at the Naval Postgraduate School.

Portions of the program must be changed as the subassembly configurations are varied in order to tailor the computations to the specific system being modeled.


```

DIMENSION EREL(1000,5),Z2(99),KAPN(20),REL(100),FAIL(100),
1TRIAL(100),RHAT(100),PROB(5),XMEAN(5),XVAR(5),XSD(5)
DATA PROB/0.2,0.1,.05,0.9,0.9/
READ(5,JSD) JSD
5 FORMAT(1I10)
JSED = JSD

      K1 = NUMBER OF SINGLE COMPONENTS IN SERIES
      K2 = NUMBER OF SUBASSEMBLIES IN SERIES
      READ(5,10) K1,K2
10   FORMAT(12I5)
      NTOT = K1
      IF(K2.LT.1) GO TO 21
      KAPN(I) = NUMBER OF COMPONENTS IN THE I-TH SUBASSEMBLY
      READ(5,12) (KAPN(I), I=1,K2)
12   FORMAT(1I6I5)
      DO 20 I=1,K2
      NTOT = NTOT+KAPN(I)
20   CONTINUE
21   CONTINUE

      READ IN COMPONENT RELIABILITIES
      K = K1+1
      READ(5,30) (REL(I), I=1,K1)
      IF(K2.LT.1) GO TO 25
      READ(5,30) (REL(I), I=K,NTOT)
25   CONTINUE

      READ IN NUMBER OF TRIALS PERFORMED UPON EACH COMPONENT
      READ(5,30) (TRIAL(I),I=1,NTOT)
30   FORMAT(8F10.4)
      KNOK = 0
      T1 = 0.0
      T2 = 0.0

      COMPUTE T VALUES FOR SERIES COMPONENTS
      DO 38 I=1,K1
      T1 = T1+TRIAL(I)*(1.0-REL(I))
38   CONTINUE

      PERFORM 1000 SIMULATIONS OF COMPONENT TEST DATA AND ESTIMATE SYSTEM REL.
      SREL
      SREL001
      SREL002
      SREL003
      SREL004
      SREL005
      SREL006
      SREL
      SREL007
      SREL008
      SREL009
      SREL010
      SREL
      SREL011
      SREL012
      SREL013
      SREL014
      SREL015
      SREL016
      SREL
      SREL017
      SREL018
      SREL019
      SREL020
      SREL021
      SREL
      SREL022
      SREL023
      SREL024
      SREL025
      SREL
      SREL025
      SREL026
      SREL027
      SREL

```



```

40 DO 120 K=1,1000
    ZK1S = 0.0
    ZK2S = 0.0
    DO 45 N=1,K1

```

DETERMINE NUMBER OF FAILURES FOR THIS COMPONENT (BINOMIALLY DISTRIBUTED)

```

45 Q = 1.0 - REL(N)
    NTEST = TRIAL(N)
    FAIL = GGBIN(JSD,NTEST,Q)
    F RAT = FAIL(N)/TRIAL(N)
    AA = (2.0*TRIAL(N)-3.0)/(2.0*TRIAL(N)-2.0)
    BB = TRIAL(N)/(TRIAL(N)-1.0)
    ZZ(N) = (AA+BB*FRAT/2.0)*FRAT
    ZK1S = ZK1S+ZZ(N)/TRIAL(N)
    ZK2S = ZK2S+ZZ(N)
    CCNTINUE
    IF (K2.LT.1) GO TO 1101

```

COMPUTE SUBASSEMBLY RESULTS

```

    KSUM = K1+K2
    KNUM = K1+1
    DO 100 N=NUM,KSUM
    KK = N-K1
    JNUM = KNUM + KAPN(KK)-1
    DO 55 NN=KNUM,JNUM
    Q = 1.0 - REL(NN)
    NTEST = TRIAL(NN)
    FAIL(NN) = GGBIN(JSD,NTEST,Q)
    RHAT(NN) = 1.0 - FAIL(NN)/TRIAL(NN)
    CCNTINUE
55

```

COMPUTE SUBASSEMBLY RELIABILITY ESTIMATES

```

56 IF (KK.GT.1) GO TO 56
    ARHAT = 1.0 - (1.0-RHAT(KNUM)*RHAT(KNUM+1))*RHAT(KNUM+2)*(1.0-
    1RHAT(KNUM+3)*RHAT(KNUM+4)*RHAT(KNUM+5))
    GC TO 90
    IF (KK.GT.2) GO TO 57
    ARHAT = 1.0 - (1.0-RHAT(KNUM)*RHAT(KNUM+1))*(1.0-RHAT(KNUM+2)*
    1RHAT(KNUM+3)*(1.0-RHAT(KNUM+4)*RHAT(KNUM+5)))
    GO TO 90
    IF (KK.GT.3) GO TO 58
    ARHAT = 1.0 - (1.0-RHAT(KNUM))*RHAT(KNUM+1)
    GC TO 90
    IF (KK.GT.4) GO TO 59

```

CC


```

104 CONTINUE
105 GO TO 112
      ARG = ZK2S**2/ZK1S
C      DETERMINE THE DEGREES OF FREEDOM FOR THE CHI-SQUARE VALUE
      DF = AMAX1(1.0,ARG)*2.0
      ACF = DF
      DF = AINT(DF)
      ADF = ADF - DF
      IF (ADF.GT.0.0) DF=DF+1.0
      DO 110 I=1,3
C      GET CHI-SQUARE VALUE
      CALL MDCHI(PROB(I),DF,CHISQ,IER)
      ERREL(K,I) = EXP(-DF*ZK2S/CHISQ)
110  CONTINUE
112  CCNTINUE
      ERREL(K,4) = ZK1S
      ERREL(K,5) = ZK2S
120  CCNTINUE
      WRITE(6,114)
C 114  FORMAT('UNORDERED RESULTS')
      WRITE(6,115)
      FORMAT(2(4X,I4,1X,5(G10.4,1X)))
      LA = 1000
      DO 130 I=1,3
C      ORDER THE ESTIMATES
      CALL VSORTA(EREL(1,I),LA)
130  CCNTINUE
C      COMPUTE TRUE SYSTEM RELIABILITY
      SREL = 1.0
      DO 135 N=K1,NTOT
      RHAT(N) = REL(N)
135  CCNTINUE
      DO 140 N=1,K1
      SREL = SREL*REL(N)
140  CCNTINUE
      IF (K2.LT.1) GO TO 147
      KNUM = NUM
      DO 146 N=NUM,KSUM
      KK = N-K1
      IF (KK.GT.1) GO TO 141

```



```

ARHAT = 1.0-(1.0-RHAT(KNUM)*RHAT(KNUM+1))*RHAT(KNUM+2)*(KNUM+2) CASE22
SREL = SREL*ARHAT CASE22
T2 = TRIAL(K1+1)*(1.0-REL(K1+1)) + TRIAL(K1+2)*(1.0-REL(K1+2)) CASE22
1 T2 + TRIAL(K1+3)*(1.0-REL(K1+3)) *REL(K1+3) CASE22
1 T2 /((1.0-REL(K1+1)*REL(K1+2)) *REL(K1+3)) CASE22
1 T3 = TRIAL(K1+4)*(1.0-REL(K1+4)) + TRIAL(K1+5)*(1.0-REL(K1+5)) CASE22
1 T3 + TRIAL(K1+6)*(1.0-REL(K1+6)) CASE22
1 T3 /((1.0-REL(K1+4)*REL(K1+5)) *REL(K1+6)) CASE22
GO TO 145 CASE22
141 IF (KK*GT*2) GO TO 142 CASE22
ARHAT = 1.0-(1.0-RHAT(KNUM)*RHAT(KNUM+1))*(1.0-RHAT(KNUM+2))*RHAT(KNUM+5) CASE22
1 RHAT = SREL*ARHAT CASE22
SREL = TRIAL(K1+7)*(1.0-REL(K1+7)) *REL(K1+8) + TRIAL(K1+8)*(1.0-REL(K1+8)) CASE22
T3 = T3/(1.0-REL(K1+7)*REL(K1+8)) CASE22
T4 = TRIAL(K1+9)*(1.0-REL(K1+9)) + TRIAL(K1+10)*(1.0-REL(K1+10)) CASE22
T4 /((1.0-REL(K1+9)*REL(K1+10)) CASE22
T5 = TRIAL(K1+11)*(1.0-REL(K1+11)) + TRIAL(K1+12)*(1.0-REL(K1+12)) CASE22
T5 /((1.0-REL(K1+11)*REL(K1+12)) CASE22
T2 = T2 + EXP ALOG(T3*T4*T5)/3.0)*(1.0-ARHAT) CASE22
GO TO 145 CASE22
142 IF (KK*GT*3) GO TO 143 CASE22
ARHAT = 1.0-(1.0-RHAT(KNUM)) * (1.0-ARHAT(KNUM+1)) CASE22
SREL = SREL*ARHAT CASE22
T2 = T2 + SQRT(TRIAL(K1+13)*TRIAL(K1+14))*(1.0-ARHAT) CASE22
GO TO 145 CASE22
143 IF (KK*GT*4) GO TO 144 CASE22
A1 = RHAT(KNUM)*RHAT(KNUM+1)*RHAT(KNUM+2)*RHAT(KNUM+3) CASE22
A2 = RHAT(KNUM+3)*RHAT(KNUM+4) CASE22
A3 = (RHAT(KNUM+4)*RHAT(KNUM+5)*RHAT(KNUM+6))**2 CASE22
A4 = RHAT(KNUM)*RHAT(KNUM+1)*RHAT(KNUM+7)*RHAT(KNUM+8) CASE22
A5 = RHAT(KNUM+4)*RHAT(KNUM+8) CASE22
A6 = RHAT(KNUM+3) CASE22
A7 = RHAT(KNUM+8) CASE22
A8 = RHAT(KNUM+9) CASE22
A9 = RHAT(KNUM+4) CASE22
ARHAT = A1*A2*A3*A8*(1.0-A6)*(1.0-A7) CASE22
ARHAT = (ARHAT+(1.0-A1)*A4*A5*A3*A8*(1.0-A7)*(1.0-A7)) ) *A9 CASE22
BRHAT = (1.0-A6)*A7+A6*(1.0-A7) CASE22
BRHAT = BRHAT*ARHAT+(1.0-A7)*A4*A5*A8 CASE22
BRHAT = BRHAT+A6*A7*A8*(1.0-(1.0-A1)*(1.0-A4)) *A2*A3*A5 CASE22
ARHAT = ARHAT+(1.0-A9)*BRHAT CASE22
SREL = SREL*ARHAT CASE22
T2 = T2 + TRIAL(K1+15)*(1.0-ARHAT) CASE22
GO TO 145 CASE22
ARHAT = 0.0 CASE22
144

```



```

KNUM = KNUM-2
DO 1144 I=2,17
ARHAT = ARHAT+RHAT (NNUM+I)**I
CONTINUE
1144 T2 = T2 + TRIAL (K1+25)*(1.0-ARHAT/16.0)
      SREL = SREL*ARHAT/16.0
      KNUM = KNUM+KAPN(KK)
      CONTINUE
      CONTINUE
C COMPUTE TOTAL TT VALUE FOR SYSTEM
C
C      TT = T1+T2
DO 149 J=1,3
      XMEAN(J) = 0.0
      XVAR(J) = 0.0
      CONTINUE
149
C COMPUTE SAMPLE MEAN AND VARIANCE OF THE ESTIMATES
C
DO 160 I=1,1000
DO 150 J=1,3
      XMEAN(J) = XMEAN(J)+EREL(I,J)
      XVAR(J) = XVAR(J)+EREL(I,J)**2
150
CONTINUE
DO 170 J=1,3
      XVAR(J) = (XVAR(J)-XMEAN(J)**2/1000.0)/999.0
      XMEAN(J) = XMEAN(J)/1000.0
      SD(J) = SQRT(XVAR(J))
170
CONTINUE
      WRITE(6,1006) JSED
1006 FORMAT('!STARTING SEED:',I12//)
      WRITE(6,194) JSD
194  FORMAT('!FINAL SEED: ',I12)
      WRITE(6,1035)
1035 FORMAT('!          COMPNT RELIABILITY TRIALS COMPNT RELIABIS')
      WRITE(6,1036) (I,REL(I,TRIAL(I)),I=1,NTOT)
1036 FORMAT(3(8X,I4)7X,F7.3,5X,F5.1)
      WRITE(6,1178) SREL
1178 FORMAT(4HO,20X,'COMPUTATION/SIMULATION RESULTS'//,I158)
      WRITE(6,179) T1,T2,TT
179  FORMAT('!T1:',F10.3,5X,'T2:',F10.3,5X,'TT:',F10.3/)
      DO 1179 I=1,3
      PROB(I) = 1.0-PROB(I)
1179
CONTINUE

```



```

180 WRITE ('6!180)(PROB(I)',I=1,3)
180 FORMAT ('CONFIDENCE LEVEL',16X,';',3X,3(F8.2,4X),'/')
180 WRITE ('6!182)EREL(800,1)EREL(900,2)EREL(950,3)
182 FORMAT ('CONF. LEVEL PERCENTILE /; ESTIMATED RELIABILITY',11X,:'SREL168
182 1,2X,3F12.5/)
184 WRITE ('6!184) (XMEAN(I)',I=1,3)
184 FORMAT ('1 ATTRIBUTES OF ',8X,', SAMPLE MEAN: ',5F12.5)
186 WRITE ('6!186) (XXVAR(I)',I=1,3)
186 FORMAT ('1 THE ESTIMATED SAMPLE VARIANCE: ',5F12.5)
188 WRITE ('6!188) (XXSD(I)',I=1,3)
188 FORMAT ('1 RELIABILITIES SAMPLE STD DEV: ',3F12.5 '/')
188 WRITE ('6!190) (EREL(1,1)',I=1,3), (EREL(250,1),I=1,3), (EREL(500,1),
1I=1,3), (EREL(750,1),I=1,3), (EREL(1000,1),I=1,3)
190 FORMAT ('1 OTHER ',20X,'MINIMUM:',3F12.5/; OBSERVED',9X,' 25TH PERCENTILE:',3F12.5/
1NTILE:',3F12.5/, SAMPLE',20X,'MEDIAN: ',3F12.5/, POINT',12X,'75TH', .
2PERCENTILE: ',3F12.5/, VALUES',19X,',MAXIMUM: ',3F12.5/ )
$      SREL179
      SREL180
      SREL181
      SREL182
      SREL183
      SREL184
      SREL185
      SREL186
      SREL187
      SREL188
      SREL189
      SREL190
      SREL190A
      SREL190B
      SREL190C
      SREL191
      SREL192
      SREL193
      SREL194
      SREL195
      SREL196
      SREL197
      SREL198
      SREL199
      SREL200
      SSTOP
      END
C 198 FORMAT ('1 ORDERED RESULTS: //',%TILE 80% CL 90% CL 90% CL
C 1L,19X,'%',TILE 90% CL 95% CL 95% CL
C 200 WRITE ('6!200) ({1,(EREL(1,K),K=1,3),I=1,1000})
      C

```


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